

# PRELIMINARY DATA SHEET Low Power DRAM (LPDDR4 FBGA) D0811PM1WDGTK-U (512Mx16bitsx1channel) C1612PM1WDGTK-U (1024Mx16bitsx1channel)

### **Specifications**

- Density: 8Gbits
- Organization
  - x 16 bits: 64M words x 16 bits x 8 banks
  - 2 pieces of 8Gb (x16) in one package (For 16Gb)
  - Row Address: R0 ~ R15
  - Column Address: C0 ~ C9
- Package
  - 200-ball FBGA
- Power supply
  - VDD1 = 1.8V (1.70V to 1.95V)
  - VDD2, VDDCÀ and VDDQ = 1.1V (1.06V to 1.17V)
- Data rate:
- 3200Mbps max.
- Eight internal banks per channel for concurrent operation
- Burst lengths (BL): 16, 32 and on-the-fly
   On the fly mode is enabled by MRS
- Programmable RL (Read Latency) and WL (Write Latency)
- Precharge: auto precharge option for each burst access
- Programmable driver strength
- Refresh: auto-refresh, self-refresh
- Refresh cycles: 8192 cycles/32ms
- Average refresh period: 3.9µs
   Operating temperature representation
  - Operating temperature range

#### TC= -25°C to +85°C

| · | °C to +85°C                    |                                |       |         |              |             |  |
|---|--------------------------------|--------------------------------|-------|---------|--------------|-------------|--|
|   | Lower Clock<br>Frequency Limit | Upper Clock<br>Frequency Limit | WRITE | Latency | READ Latency |             |  |
|   | (MHz)                          | (Mb/s/pin)                     | Set A | Set B   | DBI Disabled | DBI Enabled |  |
|   | 1066                           | 1333                           | 12    | 22      | 24           | 28          |  |
|   | 1333                           | 1600                           | 14    | 26      | 28           | 32          |  |
|   | 1600                           | 1866                           | 16    | 30      | 32           | 36          |  |
|   | Ρ                              | REL                            | IN    | IIN     | IAR          | Y           |  |



#### Features

- Low power consumption
- Per Bank Refresh
- Partial Array Self-Refresh (PASR)
  - Bank Masking
  - Segment Masking
- Auto Temperature Compensated Self-Refresh - (ATCSR) by built-in temperature sensor
- All bank auto refresh and directed per bank auto refresh supported
- Double-data-rate architecture; two data transfers per one clock cycle
- Differential clock inputs (CK\_t and CK\_c)
- Bi-directional differential data strobe (DQS\_tandDQS\_c)
- Commands entered on both rising and falling CK\_t edge; data and data mask referenced to both edges of DQS\_t
- DMI pin support for write data masking and DBIdc functionality

| Device density Number of die per device Device density (per rank) |                          | 8Gb (512M x 16 I/O x 1 channel)                   | 16Gb (1024M x 16 I/O x 1 channel)                 |  |  |
|---|--------------------------|---|---|--|--|
|   |                          | 1   | 2   |  |  |
|   |                          | 8Gb   | 8Gb   |  |  |
| Die der   | nsity                    | 8Gb   | 8Gb   |  |  |
| Device configuration  |                          | 64Mb x 1 rank(s) x 8 banks x 16 DQ x 1<br>channel | 64Mb x 2 rank(s) x 8 banks x 16 DQ x 1<br>channel |  |  |
| Number  | r of channels            | 1   | 1   |  |  |
| Number  | r of ranks               | 1   | 2   |  |  |
| Number  | r of banks (per channel) | 8   | 8   |  |  |
| Number  | r of rows (per channel)  | 65,536  | 65,536  |  |  |
| Bank ad   | ddress                   | BA0-BA2   | BA0-BA2   |  |  |
| ×16   | Row addresses            | R0-R15  | R0-R15  |  |  |
| x16   | Column addresses         | C0-C9   | C0-C9   |  |  |
| Burst st  | arting address boundary  | 64-bit  | 64-bit  |  |  |

#### Device Addressing

Notes: 1. The lower two column addresses (C0–C1) are assumed to be zero and are not transmitted on the CA bus.

2. Row and column address values on the CA bus that are not used for a particular density are "Don't Care."



## **Revision History**

| Revision No. | History         | Release date | Remark |
|--------------|-----------------|--------------|--------|
| A00          | Initial release | October 2019 |        |

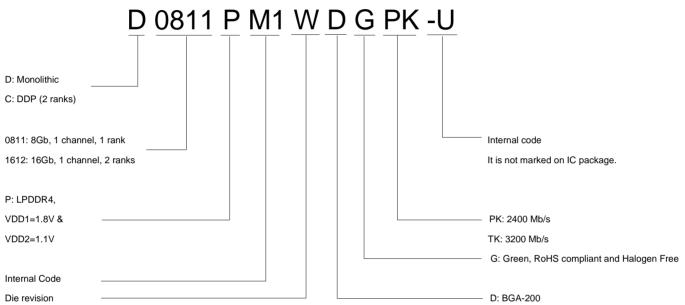
\*Products and specifications discussed herein are for evaluation and reference purposes only and are subject to change by without notice. All information discussed herein is provided on an "as is" basis, without warranties of any kind.



### **Ordering Information**

| Part number     | Die<br>revision | Organization<br>(words x bits x channels) | Internal banks | JEDEC speed | Package       |
|-----------------|-----------------|---|----------------|-------------|---------------|
| D0811PM1WDGPK-U | W Die           | 512M x 16bits x 1 channel                 | 8 banks        | 2400 Mb/s   | 200 ball FBGA |
| D0811PM1WDGTK-U | W Die           | 512M x 16bits x 1 channel                 | 8 banks        | 3200 Mb/s   | 200 ball FBGA |
| C1612PM1WDGPK-U | W Die           | 1024M x 16bits x 1 channel                | 8 banks        | 2400 Mb/s   | 200 ball FBGA |
| C1612PM1WDGTK-U | W Die           | 1024M x 16bits x 1 channel                | 8 banks        | 3200 Mb/s   | 200 ball FBGA |

### Part Number





## 1. LPDDR4 Interface

## 1.1 Pin Function and Descriptions

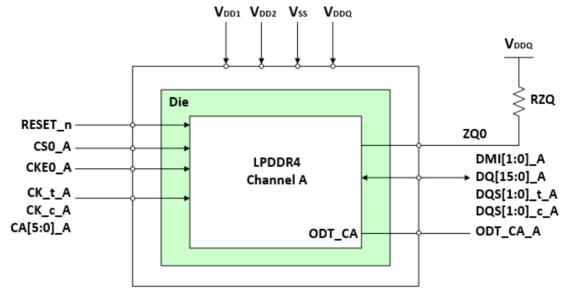
|   |        | Table — Pin Function and Descriptions  |
|---|--------|--|
| Name  | Туре   | Description  |
| CK_t_A, CK_c_A<br>CK_t_B, CK_c_B                                | Input  | <b>Clock:</b> CK_t and CK_c are differential clock inputs. All address, command, and control input signals are sampled on the crossing of the positive edge of CK_t and the negative edge of CK_c. AC timings for CA parameters are referenced to CK. Each channel (A & B) has its own clock pair.   |
| CKE0_A<br>CKE0_B  | Input  | <b>Clock Enable:</b> CKE HIGH activates and CKE LOW deactivates the internal clock circuits, input buffers, and output drivers. Power-saving modes are entered and exited via CKE transitions.<br>CKE is part of the command code. Each channel (A & B) has its own CKE signal.  |
| CS0_A<br>CS0_B  | Input  | Chip Select: CS is part of the command code. Each channel (A & B) has its own CS signal.   |
| CA[5:0]_A<br>CA[5:0]_B  | Input  | <b>Command/Address Inputs:</b> CA signals provide the Command and Address inputs according to the Command Truth Table. Each channel (A&B) has its own CA signals.  |
| ODT_CA_A<br>ODT_CA_B  | Input  | <b>CA ODT Control:</b> The ODT_CA pin is used in conjunction with the Mode Register to turn on/off the On-Die-Termination for CA pins.   |
| DQ[15:0]_A,<br>DQ[15:0]_B                                       | I/O    | Data Input/Output: Bi-direction data bus.  |
| DQS[1:0]_t_A,<br>DQS[1:0]_c_A,<br>DQS[1:0]_t_B,<br>DQS[1:0]_c_B | I/O    | <b>Data Strobe:</b> DQS_t and DQS_c are bi-directional differential output clock signals used to strobe data during a READ or WRITE. The Data Strobe is generated by the DRAM for a READ and is edge-aligned with Data. The Data Strobe is generated by the Memory Controller for a WRITE and must arrive prior to Data. Each byte of data has a Data Strobe signal pair. Each channel (A & B) has its own DQS strobes.  |
| DMI[1:0]_A,<br>DMI[1:0]_B                                       | I/O    | <b>Data Mask Inversion:</b> DMI is a bi-directional signal which is driven HIGH when the data on the data bus is inverted, or driven LOW when the data is in its normal state. Data Inversion can be disabled via a mode register setting.<br>Each byte of data has a DMI signal. Each channel (A & B) has its own DMI signals. This signal is also used along with the DQ signals to provide write data masking information to the DRAM. The DMI pin function - Data Inversion or Data mask - depends on Mode Register setting. |
| ZQ  |        | <b>Calibration Reference:</b> Used to calibrate the output drive strength and the termination resistance. There is one ZQ pin per die. The ZQ pin shall be connected to VDDQ through a $240\Omega \pm 1\%$ resistor.   |
| VDDQ,<br>VDD1,<br>VDD2  | Supply | <b>Power Supplies:</b> Isolated on the die for improved noise immunity.  |
| VSS, VSSQ   | GND    | Ground Reference: Power supply ground reference  |
| RESET_n   | Input  | <b>RESET:</b> When asserted LOW, the RESET_n signal resets all channels of the die. There is one RESET_n pad per die.  |

NOTE 1 "\_A" and "\_B" indicate DRAM channel "\_A" pads are present in all devices. "\_B" pads are present in dual channel SDRAM devices only.



### **Functional Block Diagram**

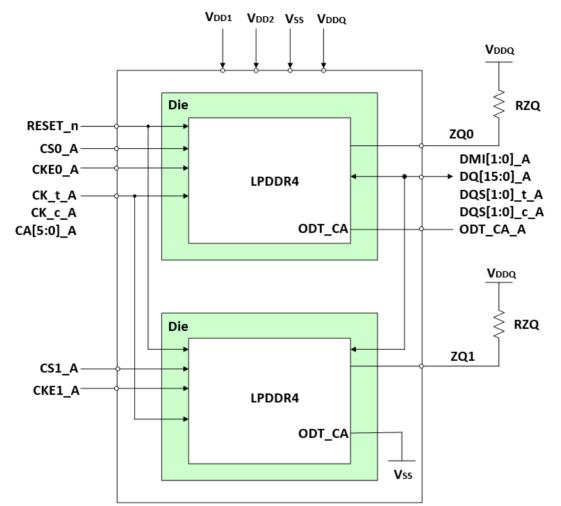
SDP



Single-Die, Single-Channel, Single-Rank Package Block Diagram (x16 I/O)



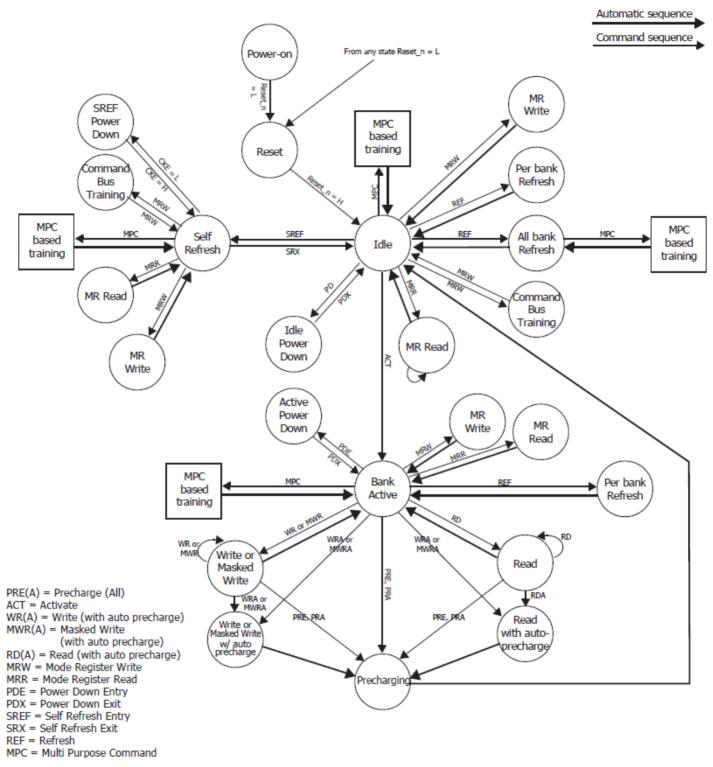
#### DDP



Dual-Die, Single-Channel, Dual-Rank Package Block Diagram (x16 I/O)



### **Simplified State Diagram**



#### Figure — Simplified Bus Interface State Diagram

Note 1: For DDR4 Mobile RAM in the Idle state, all banks are precharged.



## **1.2 Electrical Conditions**

All voltages are referenced to VSS (GND)

- Execute power-up and Initialization sequence before proper device operation is achieved.
- Operation or timing that is not specified is illegal, and after such an event, in order to guarantee proper operation, the DDR4 Mobile RAM Device must be powered down and then restarted through the specialized initialization sequence before normal operation can continue.

#### 1.2.1 Absolute maximum Ratings

|                                      |           |      | atiligo |      |      |
|--------------------------------------|-----------|------|---------|------|------|
| Parameter                            | Symbol    | min. | max.    | Unit | Note |
| VDD1 supply voltage relative to VSS  | VDD1      | -0.4 | 2.1     | V    | 2    |
| VDD2 supply voltage relative to VSS  | VDD2      | -0.4 | 1.5     | V    | 2    |
| VDDQ supply voltage relative to VSSQ | VDDQ      | -0.4 | 1.5     | V    | 2    |
| Voltage on any ball relative to VSS  | VIN, VOUT | -0.4 | 1.5     | V    |      |
| Storage Temperature                  | TSTG      | -55  | 125     | °C   | 3    |
| NL (                                 |           |      |         |      |      |

#### Table — Absolute maximum Ratings

Notes:

1. Stresses greater than those listed under "Absolute maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. See Power-Ramp section "Power-up, initialization and Power-Off" on section1.4 for relationship between power supplies

3. Storage Temperature is the case surface temperature on the center/top side of the DDR3 Mobile RAM Device. For the measurement conditions, please refer to JESD51-2 standard.

Caution

Exposing the device to stress above those listed in Absolute maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute maximum Rating conditions for extended periods may affect device reliability.

### 1.2.2 Recommended DC Operating Conditions

#### Table — Recommended DC Operating Conditions

|                                 |        |      | U    |      |      |       |
|---------------------------------|--------|------|------|------|------|-------|
| Parameter                       | Symbol | min. | Тур  | max. | Unit | Note  |
| Core Power1                     | VDD1   | 1.70 | 1.80 | 1.95 | V    | 1,2   |
| Core Power2, Input buffer power | VDD2   | 1.06 | 1.10 | 1.17 | V    | 1,2,3 |
| I/O Buffer Power                | VDDQ   | 1.06 | 1.10 | 1.17 | V    | 2,3   |
|                                 |        |      |      |      |      |       |

1. VDD1 uses significantly less current than VDD2.

2. The voltage range is for DC voltage only. DC is defined as the voltage supplied at the DRAM and is inclusive of all noise up to 20MHz at the DRAM package ball.

3. The voltage noise tolerance from DC to 20MHz exceeding a pk-pk tolerance of 45mV at the DRAM ball is not included in the TdIVW.



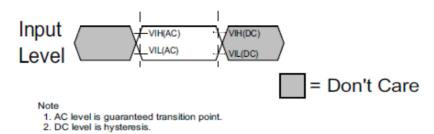
## 1.2.3 AC and DC Input Measurement Levels

### 1.2.3.1 V High speed LVCMOS (HS\_LLVCMOS)

| Parameter           | Symbol  | min.      | max.      | Unit | Note |  |  |  |  |  |
|---------------------|---------|-----------|-----------|------|------|--|--|--|--|--|
| AC input logic high | VIH(AC) | 0.75*VDD2 | VDD2+0.2  | V    | 1    |  |  |  |  |  |
| AC input logic low  | VIL(AC) | -0.2      | 0.25*VDD2 | V    | 1    |  |  |  |  |  |
| DC input logic high | VIH(DC) | 0.65*VDD2 | VDD2+0.2  | V    |      |  |  |  |  |  |
| DC input logic low  | VIL(DC) | -0.2      | 0.35*VDD2 | V    |      |  |  |  |  |  |

#### Table — LPDDR4 Input level for CKE

Note: 1. See "Overshoot and Undershoot Specifications" on section 1.2.4.

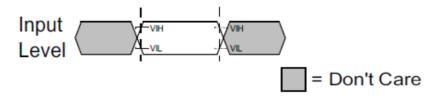


### 1.2.3.2 LPDDR4 Input Level for Reset\_n and ODT\_CA

#### Table — LPDDR4 Input level for Reset\_n and ODT\_CA

| Parameter        | Symbol | min.     | max.      | Unit | Note |
|------------------|--------|----------|-----------|------|------|
| Input high level | VIH    | 0.8*VDD2 | VDD2+0.2  | V    | 1    |
| Input low level  | VIL    | -0.2     | 0.20*VDD2 | V    | 1    |

Note: 1. See "Overshoot and Undershoot Specifications" on section 1.2.4.





## 1.2.4 AC Overshoot and Undershoot Specifications

|   | . opooi | lioution      |      |
|---|---------|---------------|------|
| Parameter   |         | Specification | Unit |
| maximum peak amplitude allowed for overshoot area.  | Max.    | 0.3           | V    |
| maximum peak amplitude allowed for undershoot area. | Max.    | 0.3           | V    |
| maximum overshoot area above VDD/VDDQ               | Max.    | 0.8           | V-ns |
| maximum undershoot area below VSS/VSSQ              | Max.    | 0.8           | V-ns |

#### Table — LPDDR4 Overshoot/Undershoot Specification

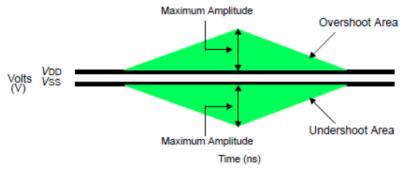


Figure — AC Overshoot and Undershoot Definition



#### 1.2.5 Differential Input Voltage 1.2.5.1 Differential Input Voltage for CK

The minimum input voltage need to satisfy both Vindiff\_CK and Vindiff\_CK /2 specification at input receiver and their measurement period is 1tCK. Vindiff\_CK is the peak to peak voltage centered on 0 volts differential and Vindiff\_CK /2 is max and min peak voltage from 0V.

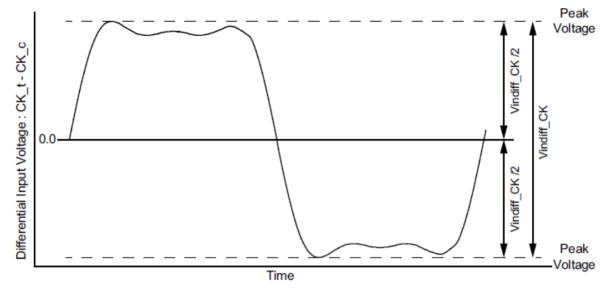


Figure — CK Differential input voltage

Table — CK Differential input voltage

|                               |            |      |       | Data    | Rate    |       |       |      |       |
|-------------------------------|------------|------|-------|---------|---------|-------|-------|------|-------|
| Parameter                     | Symbol     | 1600 | /1867 | 2133/24 | 00/3200 | 3733/ | /4267 | Unit | Notes |
|                               |            | Min  | Max   | Min     | Max     | Min   | Max   |      |       |
| CK differential input voltage | Vindiff_CK | 420  | -     | 380     | -       | 360   | -     | mV   | 1     |
| Nata                          | ····•··    |      | 1     |         | 1       |       |       |      |       |

Notes:

1. The peak voltage of Differential CK signals is calculated in a following equation.

Vindiff\_CK = (Max Peak Voltage) - (Min Peak Voltage)

Max Peak Voltage = Max(f(t)) Min Peak Voltage = Min(f(t))

 $f(t) = VCK_t - VCK_c$ 



### 1.2.5.2 Differential Input Voltage for DQS

The minimum input voltage need to satisfy both Vindiff\_DQS and Vindiff\_DQS /2 specification at input receiver and their measurement period is 1UI(tCK/2). Vindiff\_DQS is the peak to peak voltage centered on 0 volts differential and Vindiff\_DQS /2 is max and min peak voltage from 0V

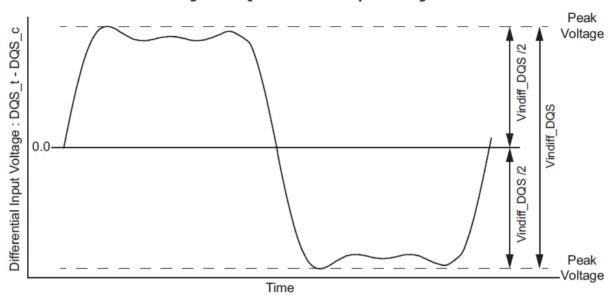


Figure - DQS Differential Input Voltage

#### Table — Differential AC and DC Input Levels

| Parameter              |             |           |     | Data           | Rate |             |     |      |       |
|------------------------|-------------|-----------|-----|----------------|------|-------------|-----|------|-------|
|                        | Symbol      | 1600/1867 |     | 2133/2400/3200 |      | 0 3733/4267 |     | Unit | Notes |
|                        |             | Min       | Max | Min            | Max  | Min         | Max |      |       |
| DQS differential input | Vindiff_DQS | 360       | -   | 360            | -    | 340         | -   | mV   | 1     |
| Mataa                  |             |           |     |                |      |             |     |      |       |

Notes:

1. The peak voltage of Differential CK signals is calculated in a following equation.

Vindiff\_DQS = (Max Peak Voltage) - (Min Peak Voltage)

Max Peak Voltage = Max(f(t))

Min Peak Voltage = Min(f(t))

f(t) = VDQS t - VDQS c



\_ \_ \_ \_ \_ \_ \_ \_ \_

### 1.2.6 Differential Input Cross Point Voltage

VDDQ ----

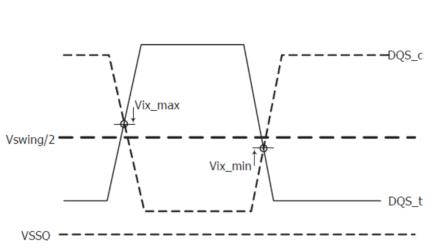


Figure — DQS input cross-point voltage (V)VIX Definition

| Deremeter  | Symbol        | Min / Data rate |           |                |           |      | Note |  |
|--|---------------|-----------------|-----------|----------------|-----------|------|------|--|
| Parameter  | Symbol        | Max             | 1600/1867 | 2133/2400/3200 | 3733/4267 | Unit | Note |  |
| DQS Differential input cross-<br>point voltage ratio | Vix_DQS_ratio | Max             | 20        | 20             | 20        | %    | 1,2  |  |
| Notes:   |               |                 |           |                |           |      |      |  |

| Table — DQS input voltage cross-point (Vix) ratio | Table — | DQS input volta | age cross-point | (Vix) ratio |
|---|---------|-----------------|-----------------|-------------|
|---|---------|-----------------|-----------------|-------------|

1. The Vix voltage is referenced to Vswing/2(avg)= 0.5(VDQS\_t + VDQS\_c) where the average is over tbd UI.

2. The ratio of the Vix pk voltage divided by Vdiff\_DQS : Vix\_DQS\_Ratio = 100\* (Vix\_DQS/Vdiff DQS pk-pk) where VdiffDQS pk-pk = 2\*|VDQS\_t - VDQS\_c|.





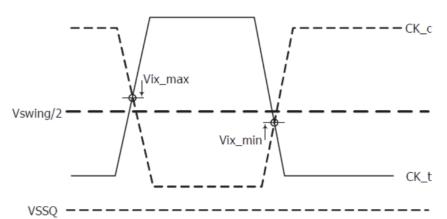


Figure — CK input cross-point voltage (Vix)

| Deremeter   | Symbol       | Min / |           | Data rate      |           | Linit | Note |
|---|--------------|-------|-----------|----------------|-----------|-------|------|
| Parameter   | Symbol       | Max   | 1600/1867 | 2133/2400/3200 | 3733/4267 | Unit  | Note |
| CK Differential input cross-<br>point voltage ratio | Vix_CK_ratio | Max   | 25        | 25             | 25        | %     | 1,2  |

- The Vix voltage is referenced to Vswing/2(avg)= 0.5(VCK\_t + VCK\_c) where the average is over tbd UI.
   The ratio of the Vix pk voltage divided by Vdiff\_CK : Vix\_CK\_Ratio = 100\* (Vix\_CK/Vdiff CK pk-pk) where VdiffCK pk-pk  $= 2^{*}|VCK_t - VCK_c|$

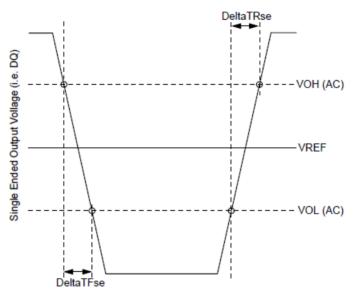


### 1.2.6.1 Single Ended Output Slew Rate

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC) for single ended signals as shown in Table 14 and Figure 8.

| Description                                    | Meas    | sured   | Defined by                      |
|--|---------|---------|---------------------------------|
| Description                                    | from    | to      | Defined by                      |
| Single-ended output slew rate for rising edge  | VOL(AC) | VOH(AC) | [VOH(AC) – VOL(AC)] / DeltaTRse |
| Single-ended output slew rate for falling edge | VOH(AC) | VOL(AC) | [VOH(AC) – VOL(AC)] / DeltaTFse |





#### Figure — Single Ended Output Slew Rate Definition

| I able — Output Siew Nate (Single-cilue) | Dutput Slew Rate (single-ended | Rate | Slew | - Output | Table — |
|--|--------------------------------|------|------|----------|---------|
|--|--------------------------------|------|------|----------|---------|

| Parameter                                      | Symbol | min. | max. | Unit |
|--|--------|------|------|------|
| Single-ended Output Slew Rate (VOH = VDDQ/3)   | SRQse  | 3.0  | 9    | V/ns |
| Output slew-rate matching Ratio (Rise to Fall) |        | 0.8  | 1.2  |      |

Remark: SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), se: Single-ended Signals

Notes:

- 1. Measured with output reference load.
- 2. The ratio of pull-up to pull-down slew rate is specified for the same temperature and voltage, over the entire temperature and voltage range. For a given output, it represents the maximum difference between pull-up and pulldown drivers due to process variation.
- 3. The output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC).
- 4. Slew rates are measured under normal SSO conditions, with 1/2 of DQ signals per data byte driving logic high and 1/2 of DQ signals per data byte driving logic low.



#### 1.2.7 **Differential Output Slew Rate**

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between VOLdiff(AC) and VOHdiff(AC) for differential signals as shown in Table 16 and Figure 9.

| Table — Differential Output Slew Rate Definition |      |      |            |  |  |  |  |  |  |  |
|--|------|------|------------|--|--|--|--|--|--|--|
| Description                                      | Meas | ured | Defined by |  |  |  |  |  |  |  |
| Description                                      |      |      | Delined by |  |  |  |  |  |  |  |

| Table — Differential Output Slew | <b>Rate Definition</b> |
|----------------------------------|------------------------|
|----------------------------------|------------------------|

| F · · ·  | from        | to          | ,   |
|--|-------------|-------------|---|
| Differential output slew rate for rising edge  | VOLdiff(AC) | VOHdiff(AC) | [VOHdiff(AC) – VOLdiff(AC)] / DeltaTRdiff |
| Differential output slew rate for falling edge | VOHdiff(AC) | VOLdiff(AC) | [VOHdiff(AC) – VOLdiff(AC)] / DeltaTFdiff |
|  |             |             |   |

Note: 1. Output slew rate is verified by design and characterization, and may not be subject to production test.

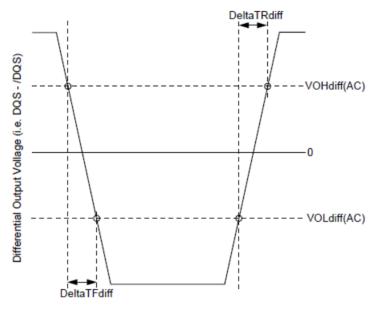


Figure — Differential Output Slew Rate Definition

| Table — | Differential | Output | Slew | Rate |  |
|---------|--------------|--------|------|------|--|
|         |              |        |      |      |  |

| Parameter                                      | Symbol                  | min.       | max. | Unit |
|--|-------------------------|------------|------|------|
| Differential Output Slew Rate (VOH=VDDQ x 0.5) | SRQdiff                 | 6          | 18   | V/ns |
|  | ( <b>D</b> ( <b>D</b> ) | <b>•</b> • |      |      |

Remark: SR: Slew Rate, Q: Query Output (like in DQ, which stands for Data-in, Query-Output), diff: Differential Signals

Notes:

1. Measured with output reference load.

2. The output slew rate for falling and rising edges is defined and measured between VOL(AC) and VOH(AC).

3. Slew rates are measured under normal SSO conditions, with 1/2 of DQ signals per data byte driving logic high and 1/2 of DQ signals per data byte driving logic low.



## **1.3 Electrical Specifications**

### 1.3.1 IDD Measurement Conditions

The following definitions are used within the IDD measurement tables: LOW: VIN  $\leq$  VIL(DC) max. HIGH: VIN  $\geq$  VIH(DC) min. STABLE: Inputs are stable at a HIGH or LOW level

| Switching for CA |      |      |      |      |      |      |      |      |  |
|------------------|------|------|------|------|------|------|------|------|--|
| CK_t edge        | R1   | R2   | R3   | R4   | R5   | R6   | R7   | R8   |  |
| CKE              | HIGH |  |
| CS               | LOW  |  |
| CA0              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |  |
| CA1              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |  |
| CA2              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |  |
| CA3              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |  |
| CA4              | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH | HIGH | HIGH |  |
| CA5              | HIGH | HIGH | HIGH | LOW  | LOW  | LOW  | LOW  | HIGH |  |
|                  |      |      |      |      |      |      |      |      |  |

#### Table — Definition of Switching for CA Input Signals

Notes:

1. CS must always be driven LOW.

2. 50% of CA bus is changing between HIGH and LOW once per clock for the CA bus.

3. The above pattern is used continuously during IDD measurement for IDD values that require switching on the CA bus.

| Clock Cycle Number | CKE  | CS   | Command  | CA0 | CA1 | CA2 | CA3 | CA4 | CA5 |
|--------------------|------|------|----------|-----|-----|-----|-----|-----|-----|
| N                  | HIGH | HIGH | Deed 4   | L   | Н   | L   | L   | L   | L   |
| N+1                | HIGH | LOW  | Read-1   | L   | Н   | L   | L   | L   | L   |
| N+2                | HIGH | HIGH | CAS-2    | L   | Н   | L   | L   | Н   | L   |
| N+3                | HIGH | LOW  |          | L   | L   | L   | L   | L   | L   |
| N+4                | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+5                | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+6                | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+7                | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+8                | HIGH | HIGH | Dood 1   | L   | Н   | L   | L   | L   | L   |
| N+9                | HIGH | LOW  | Read-1   | L   | Н   | L   | L   | Н   | L   |
| N+10               | HIGH | HIGH |          | L   | Н   | L   | L   | Н   | Н   |
| N+11               | HIGH | LOW  | CAS-2    | Н   | Н   | н   | Н   | Н   | Н   |
| N+12               | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+13               | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+14               | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |
| N+15               | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |

### Table — CA pattern for IDD4R for BL = 16

Notes:

1. BA[2:0] = 010, CA[9:4] = 000000 or 111111, Burst Order CA[3:2] = 00 or 11 (Same as LPDDR3 IDD4R Spec)

2. Difference from LPDDR3 Spec : CA pins are kept low with DES CMD to reduce ODT current.



| Table — CA pattern for IDD4w for BL = 16 |      |      |          |     |     |     |     |     |     |  |  |
|--|------|------|----------|-----|-----|-----|-----|-----|-----|--|--|
| Clock Cycle<br>Number                    | CKE  | CS   | Command  | CA0 | CA1 | CA2 | CA3 | CA4 | CA5 |  |  |
| N  | HIGH | HIGH | Write-1  | L   | L   | Н   | L   | L   | L   |  |  |
| N+1                                      | HIGH | LOW  | write-1  | L   | Н   | L   | L   | L   | L   |  |  |
| N+2                                      | HIGH | HIGH | CAS-2    | L   | н   | L   | L   | н   | L   |  |  |
| N+3                                      | HIGH | LOW  |          | L   | L   | L   | L   | L   | L   |  |  |
| N+4                                      | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+5                                      | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+6                                      | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+7                                      | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+8                                      | HIGH | HIGH |          | L   | L   | н   | L   | L   | L   |  |  |
| N+9                                      | HIGH | LOW  | Write-1  | L   | н   | L   | L   | н   | L   |  |  |
| N+10                                     | HIGH | HIGH | CAR 2    | L   | н   | L   | L   | н   | Н   |  |  |
| N+11                                     | HIGH | LOW  | CAS-2    | L   | L   | н   | Н   | н   | Н   |  |  |
| N+12                                     | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+13                                     | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+14                                     | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| N+15                                     | HIGH | LOW  | Deselect | L   | L   | L   | L   | L   | L   |  |  |
| Notoo                                    |      |      |          |     |     |     |     |     |     |  |  |

Table — CA pattern for IDD4W for BL = 16

1. BA[2:0] = 010, CA[9:4] = 000000 or 111111 (Same as LPDDR3 IDD4W Spec.)

2. Difference from LPDDR3 Spec:

1-No burst ordering

2-CA pins are kept low with DES CMD to reduce ODT current.

|      |       |       |       | DBI OF |       |       |       |       |     | No. of 1's |  |  |  |
|------|-------|-------|-------|--------|-------|-------|-------|-------|-----|------------|--|--|--|
|      | DQ[7] | DQ[6] | DQ[5] | DQ[4]  | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI | 110.0113   |  |  |  |
| BL0  | 1     | 1     | 1     | 1      | 1     | 1     | 1     | 1     | 0   | 8          |  |  |  |
| BL1  | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |  |  |  |
| BL2  | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |  |  |  |
| BL3  | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |  |  |  |
| BL4  | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |  |  |  |
| BL5  | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |  |  |  |
| BL6  | 1     | 1     | 1     | 1      | 1     | 1     | 0     | 0     | 0   | 6          |  |  |  |
| BL7  | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |  |  |  |
| BL8  | 1     | 1     | 1     | 1      | 1     | 1     | 1     | 1     | 0   | 8          |  |  |  |
| BL9  | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |  |  |  |
| BL10 | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |  |  |  |
| BL11 | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |  |  |  |
| BL12 | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |  |  |  |
| BL13 | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |  |  |  |
| BL14 | 1     | 1     | 1     | 1      | 1     | 1     | 0     | 0     | 0   | 6          |  |  |  |
| BL15 | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |  |  |  |
| BL16 | 1     | 1     | 1     | 1      | 1     | 1     | 0     | 0     | 0   | 6          |  |  |  |
| BL17 | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |  |  |  |
| BL18 | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |  |  |  |
| BL19 | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |  |  |  |



| BL20       | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0 | 0 |
|------------|----|----|----|----|----|----|----|----|---|---|
| BL21       | 0  | 0  | 0  | 0  | 1  | 1  | 1  | 1  | 0 | 4 |
| BL22       | 1  | 1  | 1  | 1  | 1  | 1  | 1  | 1  | 0 | 8 |
| BL23       | 1  | 1  | 1  | 1  | 0  | 0  | 0  | 0  | 0 | 4 |
| BL24       | 0  | 0  | 0  | 0  | 0  | 0  | 1  | 1  | 0 | 2 |
| BL25       | 0  | 0  | 0  | 0  | 1  | 1  | 1  | 1  | 0 | 4 |
| BL26       | 1  | 1  | 1  | 1  | 1  | 1  | 0  | 0  | 0 | 6 |
| BL27       | 1  | 1  | 1  | 1  | 0  | 0  | 0  | 0  | 0 | 4 |
| BL28       | 1  | 1  | 1  | 1  | 1  | 1  | 1  | 1  | 0 | 8 |
| BL29       | 1  | 1  | 1  | 1  | 0  | 0  | 0  | 0  | 0 | 4 |
| BL30       | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0  | 0 | 0 |
| BL31       | 0  | 0  | 0  | 0  | 1  | 1  | 1  | 1  | 0 | 4 |
| No. of 1's | 16 | 16 | 16 | 16 | 16 | 16 | 16 | 16 |   |   |

 Simplified pattern compared with last showing.
 Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming.

| DBI OFF case |          |       |       |       |       |          |          |          |     |            |
|--------------|----------|-------|-------|-------|-------|----------|----------|----------|-----|------------|
|              | DQ[7]    | DQ[6] | DQ[5] | DQ[4] | DQ[3] | DQ[2]    | DQ[1]    | DQ[0]    | DBI | No. of 1's |
| BL0          | <u> </u> | 1     | 1     | 1     | 1     | <u> </u> | <u> </u> | <u> </u> | 0   | 8          |
| BL1          | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL2          | 0        | 0     | 0     | 0     | 0     | 0        | 0        | 0        | 0   | 0          |
| BL3          | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL4          | 0        | 0     | 0     | 0     | 0     | 0        | 1        | 1        | 0   | 2          |
| BL5          | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL6          | 1        | 1     | 1     | 1     | 1     | 1        | 0        | 0        | 0   | 6          |
| BL7          | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL8          | 1        | 1     | 1     | 1     | 1     | 1        | 1        | 1        | 0   | 8          |
| BL9          | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL10         | 0        | 0     | 0     | 0     | 0     | 0        | 0        | 0        | 0   | 0          |
| BL11         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL12         | 0        | 0     | 0     | 0     | 0     | 0        | 1        | 1        | 0   | 2          |
| BL13         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL14         | 1        | 1     | 1     | 1     | 1     | 1        | 0        | 0        | 0   | 6          |
| BL15         | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL16         | 1        | 1     | 1     | 1     | 1     | 1        | 1        | 1        | 0   | 8          |
| BL17         | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL18         | 0        | 0     | 0     | 0     | 0     | 0        | 0        | 0        | 0   | 0          |
| BL19         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL20         | 1        | 1     | 1     | 1     | 1     | 1        | 0        | 0        | 0   | 6          |
| BL21         | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL22         | 0        | 0     | 0     | 0     | 0     | 0        | 1        | 1        | 0   | 2          |
| BL23         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL24         | 0        | 0     | 0     | 0     | 0     | 0        | 0        | 0        | 0   | 0          |
| BL25         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL26         | 1        | 1     | 1     | 1     | 1     | 1        | 1        | 1        | 0   | 8          |
| BL27         | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| BL28         | 0        | 0     | 0     | 0     | 0     | 0        | 1        | 1        | 0   | 2          |
| BL29         | 0        | 0     | 0     | 0     | 1     | 1        | 1        | 1        | 0   | 4          |
| BL30         | 1        | 1     | 1     | 1     | 1     | 1        | 0        | 0        | 0   | 6          |
| BL31         | 1        | 1     | 1     | 1     | 0     | 0        | 0        | 0        | 0   | 4          |
| No. of 1's   | 16       | 16    | 16    | 16    | 16    | 16       | 16       | 16       |     |            |

### Table — Data pattern for IDD4R (DBI off) for BL =16



1. Same data pattern was applied to DQ[4], DQ[5], DQ[6], DQ[7] for reducing complexity for IDD4W/R pattern programming.

|            |       | Table | Bata  | DBI ON |       |       |       | _ 10  |     |            |
|------------|-------|-------|-------|--------|-------|-------|-------|-------|-----|------------|
|            | DQ[7] | DQ[6] | DQ[5] | DQ[4]  | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI | No. of 1's |
| BL0        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL1        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3        | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4        | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5        | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6        | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL7        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL9        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL15       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL16       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL17       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL19       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL21       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL22       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL23       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL24       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL25       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL27       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL29       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL30       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL31       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| No. of 1's | 8     | 8     | 8     | 8      | 8     | 8     | 16    | 16    | 8   |            |

#### Table — Data pattern for IDD4W (DBI on) for BL = 16

Notes:

1. Green colored cells are DBI enabled burst.



|            |       |       |       | DBI ON |       |       | ,     |       |     |            |
|------------|-------|-------|-------|--------|-------|-------|-------|-------|-----|------------|
|            | DQ[7] | DQ[6] | DQ[5] | DQ[4]  | DQ[3] | DQ[2] | DQ[1] | DQ[0] | DBI | No. of 1's |
| BL0        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL1        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL2        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL3        | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL4        | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL5        | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL6        | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL7        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL8        | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL9        | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL10       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL11       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL12       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL13       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL14       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL15       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL16       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL17       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL18       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL19       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL20       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL21       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL22       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL23       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL24       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 0   | 0          |
| BL25       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL26       | 0     | 0     | 0     | 0      | 0     | 0     | 0     | 0     | 1   | 1          |
| BL27       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| BL28       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 0   | 2          |
| BL29       | 0     | 0     | 0     | 0      | 1     | 1     | 1     | 1     | 0   | 4          |
| BL30       | 0     | 0     | 0     | 0      | 0     | 0     | 1     | 1     | 1   | 3          |
| BL31       | 1     | 1     | 1     | 1      | 0     | 0     | 0     | 0     | 0   | 4          |
| No. of 1's | 8     | 8     | 8     | 8      | 8     | 8     | 16    | 16    | 8   |            |

### Table — Data pattern for IDD4R (DBI on) for BL = 16

Notes:

1. Green colored cells are DBI enabled burst.



### 1.3.2 IDD Specifications

IDD values are for the entire operating voltage range, and all of them are for the entire standard range, with the exception of IDD6ET which is for the entire extended temperature range.

#### Table — IDD Specification Parameters and Operating Conditions-Single Die

|  |          |              |             | gie Di | •     |
|--|----------|--------------|-------------|--------|-------|
| Parameter/Condition                              | Symbol   | Power Supply | LPDDR4-3733 | Units  | Notes |
| Operating one bank active-precharge<br>current:  | IDD01    | VDD1         | 3.50        | mA     |       |
| tCK = tCKmin; tRC = tRCmin;                      | IDD02    | VDD2         | 45.00       | mA     |       |
| CKE is HIGH;                                     |          |              |             |        |       |
| CS is LOW between valid commands;                |          |              |             |        |       |
| CA bus inputs are switching;                     | IDD0Q    | VDDQ         | 0.75        | mA     | 3     |
| Data bus inputs are stable;                      |          |              |             |        |       |
| ODT disabled                                     |          |              |             |        |       |
| Idle power-down standby current:                 | IDD2P1   | VDD1         | 1.00        | mA     |       |
| tCK = tCKmin;                                    | IDD2P2   | VDD2         | 2.00        | mA     |       |
| CKE is LOW;                                      |          |              |             |        |       |
| CS is LOW;                                       |          |              |             |        |       |
| All banks are idle;                              |          | VDDQ         |             | ~^^    | 3     |
| CA bus inputs are switching;                     | IDD2PQ   | VDDQ         | 0.75        | mA     | 3     |
| Data bus inputs are stable;                      |          |              |             |        |       |
| ODT disabled                                     |          |              |             |        |       |
| Idle power-down standby current with clock stop: | IDD2PS1  | VDD1         | 1.00        | mA     |       |
| CK_t =LOW, CK_c =HIGH;                           | IDD2PS2  | VDD2         | 2.00        | mA     |       |
| CKE is LOW;                                      |          |              |             |        |       |
| CS is LOW;                                       |          |              |             |        |       |
| All banks are idle;                              | IDD2PSQ  | VDDQ         | 0.75        | mA     | 3     |
| CA bus inputs are stable;                        | ibbel oq | VDDQ         | 0.75        |        | Ũ     |
| Data bus inputs are stable                       |          |              |             |        |       |
| ODT is disabled.                                 |          |              |             |        |       |
| Idle non power-down standby current:             | IDD2N1   | VDD1         | 1.20        | mA     |       |
| tCK = tCKmin;                                    | IDD2N2   | VDD2         | 27.00       | mA     |       |
| CKE is HIGH;                                     |          |              |             |        |       |
| CS is LOW;                                       |          |              |             |        |       |
| All banks are idle;                              | IDD2Nq   | VDDQ         | 0.75        | mA     | 3     |
| CA bus inputs are switching;                     |          |              | 0.75        | ШA     | 5     |
| Data bus inputs are stable                       |          |              |             |        |       |
| ODT is disabled.                                 |          |              |             |        |       |



| Parameter/Condition                      | Symbol  | Power Supply                            | LPDDR4-3733 | Units | Notes |
|--|---------|---|-------------|-------|-------|
| Idle non power-down standby current with | IDD2NS1 | VDD1                                    | 1.20        | mA    |       |
| clock stopped:<br>CK_t=LOW; CK_c=HIGH;   | IDD2NS2 | VDD2                                    | 20.00       | mA    |       |
| CKE is HIGH;                             |         |   |             |       |       |
| CS is LOW;                               |         |   |             |       |       |
| All banks are idle;                      |         |   |             |       |       |
| CA bus inputs are stable;                | IDD2NSQ | VDDQ                                    | 0.75        | mA    | 3     |
| Data bus inputs are stable               |         |   |             |       |       |
| ODT disabled                             |         |   |             |       |       |
| Active power-down standby current:       | IDD3P1  | VDD1                                    | 1.00        | mA    |       |
| tCK = tCKmin;                            |         |   |             |       |       |
| CKE is LOW;                              | IDD3P2  | VDD2                                    | 10.00       | mA    |       |
| CS is LOW;                               |         |   |             |       |       |
| One bank is active;                      |         |   |             |       |       |
| CA bus inputs are switching;             | IDD3PQ  | VDDQ                                    | 0.75        | mA    | 3     |
| Data bus inputs are stable               |         |   |             |       |       |
| ODT disabled                             |         |   |             |       |       |
| Active power-down standby current with   | IDD3PS1 | VDD1                                    | 1.00        | mA    |       |
| clock stop:                              | IDD3PS2 | VDD2                                    | 10.00       | mA    |       |
| CK_t=LOW, CK_c=HIGH;                     |         |   |             |       |       |
| CKE is LOW;                              |         |   |             |       |       |
| CS is LOW;                               |         |   |             |       |       |
| One bank is active;                      | IDD3PSQ | VDDQ                                    | 0.75        | mA    | 4     |
| CA bus inputs are stable;                |         |   |             |       |       |
| Data bus inputs are stable               |         |   |             |       |       |
| ODT disabled                             |         |   |             |       |       |
| Active non-power-down standby current:   | IDD3N1  | VDD1                                    | 1.50        | mA    |       |
| tCK = tCKmin;                            | IDD3N2  | VDD2                                    | 30.00       | mA    |       |
| CKE is HIGH;                             |         |   |             |       |       |
| CS is LOW;                               |         |   |             |       |       |
| One bank is active;                      | IDD3Ng  | VDDQ                                    | 0.75        | mA    | 4     |
| CA bus inputs are switching;             | 1000110 | ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,, | 0.75        |       | т     |
| Data bus inputs are stable               |         |   |             |       |       |
| ODT disabled                             |         |   |             |       |       |



| Parameter/Condition  | Symbol  | Power Supply | LPDDR4-3733 | Units | Notes |
|--|---------|--------------|-------------|-------|-------|
| Active non-power-down standby current<br>with clock stopped: | IDD3NS1 | VDD1         | 1.50        | mA    |       |
| CK_t=LOW, CK_c=HIGH;   | IDD3NS2 | VDD2         | 26.00       | mA    |       |
| CKE is HIGH;   |         |              |             |       |       |
| CS is LOW;   |         |              |             |       |       |
| One bank is active;  | IDD3NSo |              | 0.75        |       | 4     |
| CA bus inputs are stable;                                    | IDD3NSQ | VDDQ         | 0.75        | mA    | 4     |
| Data bus inputs are stable                                   |         |              |             |       |       |
| ODT disabled   |         |              |             |       |       |
| Operating burst READ current:                                | IDD4R1  | VDD1         | 3.20        | mA    |       |
| tCK = tCKmin;  | IDD4R2  | VDD2         | 300.00      | mA    |       |
| CS is LOW between valid commands;                            |         | VDD2         | 000.00      |       |       |
| One bank is active;  |         |              |             |       |       |
| BL = 16 or 32; RL = RL(MIN);                                 |         |              |             |       | _     |
| CA bus inputs are switching;                                 | IDD4RQ  | VDDQ         | 62.64       | mA    | 5     |
| 50% data change each burst transfer                          |         |              |             |       |       |
| ODT disabled.  |         |              |             |       |       |
| Operating burst WRITE current:                               | IDD4W1  | VDD1         | 2.00        | mA    |       |
| tCK = tCKmin;  | IDD4W2  | VDD2         | 260.00      | mA    |       |
| CS is LOW between valid commands;                            |         |              |             |       |       |
| One bank is active;  |         |              |             |       |       |
| BL = 16 or 32; WL = WLmin;                                   | IDD4WQ  | VDDQ         | 0.75        | mA    | 4     |
| CA bus inputs are switching;                                 | IDD4WQ  | VDDQ         | 0.75        |       | -     |
| 50% data change each burst transfer                          |         |              |             |       |       |
| ODT disabled   |         |              |             |       |       |
| All-bank REFRESH Burst current:                              | IDD51   | VDD1         | 12.00       | mA    |       |
| tCK = tCKmin;  | IDD52   | VDD2         | 110.00      | mA    |       |
| CKE is HIGH between valid commands;                          |         |              |             |       |       |
| tRC = tRFCabmin;   |         |              |             |       |       |
| Burst refresh;   | IDD5Q   | VDDQ         | 0.75        | mA    | 4     |
| CA bus inputs are switching;                                 |         |              |             |       |       |
| Data bus inputs are stable;                                  |         |              |             |       |       |
| ODT disabled   |         |              |             |       |       |



| Parameter/Condition                 | Symbol  | Power Supply | LPDDR4-3733 | Units | Notes   |
|-------------------------------------|---------|--------------|-------------|-------|---------|
| All-bank REFRESH Average current:   | IDD5AB1 | VDD1         | 1.70        | mA    |         |
| tCK = tCKmin;                       | IDD5AB2 | VDD2         | 30.00       | mA    |         |
| CKE is HIGH between valid commands; |         |              |             |       |         |
| tRC = tREFI;                        |         |              |             |       |         |
| CA bus inputs are switching;        | IDD5ABQ | VDDQ         | 0.75        | mA    | 4       |
| Data bus inputs are stable;         |         |              |             |       |         |
| ODT disabled                        |         |              |             |       |         |
| Per-bank REFRESH Average current:   | IDD5PB1 | VDD1         | 1.70        | mA    |         |
| tCK = tCKmin;                       | IDD5PB2 | VDD2         | 30.00       | mA    |         |
| CKE is HIGH between valid commands; |         |              |             |       |         |
| tRC = tREFI/8;                      |         |              |             |       |         |
| CA bus inputs are switching;        | IDD5PBQ | VDDQ         | 0.75        | mA    | 4       |
| Data bus inputs are stable;         |         |              |             |       |         |
| ODT disabled                        |         |              |             |       |         |
| Self refresh current (85°C):        | IDD61   | VDD1         | 1.50        | mA    | 6,7,9   |
| CK_t=LOW, CK_c=HIGH;                | IDD62   | VDD2         | 6.00        | mA    | 6,7,9   |
| CKE is LOW;                         |         |              |             |       |         |
| CA bus inputs are stable;           | IDD6Q   | VDDQ         | 0.75        | mA    | 4,6,7,9 |
| Data bus inputs are stable;         | ibboq   | VDDQ         | 0.75        |       | 4,0,7,0 |
| ODT disabled                        |         |              |             |       |         |
| Self refresh current (25°C):        | IDD61   | VDD1         | 0.19        | mA    | 6,7,9   |
| CK_t=LOW, CK_c=HIGH;                | IDD61   | VDD2         | 0.47        | mA    | 6,7,9   |
| CKE is LOW;                         |         |              |             |       |         |
| CA bus inputs are stable;           | 1000    |              |             |       | 4070    |
| Data bus inputs are stable;         | IDD6Q   | VDDQ         | 0.01        | mA    | 4,6,7,9 |
| ODT disabled                        |         |              |             |       |         |

1. Published IDD values are the maximum of the distribution of the arithmetic mean.

2. ODT disabled: MR11[2:0] = 000B.

3. IDD current specifications are tested after the device is properly initialized.

4. Measured currents are the summation of VDDQ and VDD2.

5. Guaranteed by design with output load = 5pF and RON = 40 ohm.

6. This is the general definition that applies to full array Self Refresh.

7. Supplier datasheets may contain additional Self Refresh IDD values for temperature subranges within the Standard or elevated Temperature Ranges.

8. For all IDD measurements, VIHCKE = 0.8 x VDD2, VILCKE = 0.2 x VDD2.

9. IDD6 85°C is guaranteed, IDD6 25/105°C is typical of the distribution of the arithmetic mean.

10. IDD6ET is a typical value, is sampled only, and is not tested.



### 1.3.3 AC Timing Parameters

| Parameter                                     | Symbol | min/ | Data Rate Unit   | Note |
|---|--------|------|--|------|
|   | Cymbol | max  | 533 1066 1600 2133 2667 3200 3733 4267   |      |
| ACTIVE to ACTIVE command period               | tRC    | min  | tRAS + tRPab (with all-bank precharge)<br>tRAS + tRPpb (with per-bank precharge) |      |
| Minimum Self-Refresh Time (Entry to Exit)     | tSR    | min  | max(15ns, 3nCK) ns   |      |
| Self Refresh exit to next valid command delay | tXSR   | min  | max(tRFCab + 7.5ns, 2nCK) ns   |      |
| Exit power down to next valid command delay   | tXP    | min  | max(7.5ns, 5nCK) ns  |      |
| CAS to CAS delay                              | tCCD   | min  | 8 tCK(avg)   |      |
| CAS to CAS delay (Masked Write w/ECC)         | tCCDMW | min  | 32 tCK(avg)  |      |
| Internal Read to Precharge command delay      | tRTP   | min  | max(7.5ns, 8nCK) ns  |      |
| RAS to CAS Delay                              | tRCD   | min  | max(18ns, 4nCK) ns   |      |
| Row Precharge Time (single bank)              | tRPpb  | min  | max(18ns, 3nCK) ns   |      |
| Row Precharge Time (all banks) - 8-bank       | tRPab  | min  | max(21ns, 3nCK) ns   |      |
|   | (540   | min  | max(42ns, 3nCK) ns   |      |
| Row Active Time                               | tRAS   | max  | min(9 * tREFI * Refresh Rate, 70.2) us   |      |
| Write Recovery Time                           | tWR    | min  | max(18ns, 4nCK) ns   |      |
| Write to Read Command Delay                   | tWTR   | min  | max(10ns, 8nCK) ns   |      |
| Active bank A to Active bank B                | tRRD   | min  | max(10ns, 4ncK)<br>max(10ns, 4ncK)<br>max(<br>7.5n<br>s,4n<br>CK)                | 1    |
| Precharge to Precharge Delay                  | tPPD   | min  | 4 tCK  | 2    |
| Four Bank Activate Window                     | tFAW   | min  | 40 30 ns   | 1    |
| Delay from SRE command to CKE input<br>LOW    | tESCKE | min  | max(1.75ns, 3nCK) -  | 3    |

### Table — Core Parameters

Notes:

1. 4267 Mbps timing value is supported at lower data rates if the device is supporting 4266 Mbps speed grade.

2. Precharge to precharge timing restriction does not apply to Auto-Precharge commands.

3. Delay time has to satisfy both analog time (ns) and clock count (nCK). It means that tESCKE will not expire until CK has toggled through at least three full cycle (3 tCK) and 1.75ns has transpired. The case which 3nCK is applied to is shown below.



| Parameter                        | Symbol             | min/max | LPDDR4<br>1600 | LPDDR4<br>3200 | LPDDR4<br>3733 | LPDDR4<br>4267 | Unit       | Note |
|----------------------------------|--------------------|---------|----------------|----------------|----------------|----------------|------------|------|
| Average Clock Period             | tCK(avg)           | min     | 1.25           | 0.625          | 0.535          | 0.468          |            |      |
| Average Clock Period             | iCr(avy)           | max     | 100            | 100            | 100            | 100            | ns         |      |
| Average high pulse width         | tCH(avg)           | min     |                | 0.4            |                | tCK(ava)       |            |      |
| Average high pulse width         | iCn(avy)           | max     |                | 0.             | 54             |                | tCK(avg)   |      |
| Average low pulse width          | tCL(avg)           | min     |                | 0.4            | 46             |                | tCK(avg)   |      |
| Average low pulse width          | iCL(avg)           | max     |                | 0.             |                | iCK(avy)       |            |      |
| Absolute Clock Period            | tCK(abs)           | min     | tCK            | (avg)min ·     | + tJIT(per)    | min            | ps         |      |
|                                  | tOLI(aba)          | min     |                | 0.4            | 43             |                |            |      |
| Absolute clock HIGH pulse width  | tCH(abs)           | max     |                | 0.             | 57             |                | tCK(avg)   |      |
| Abaqluta alaqlı I QM pulaq width | tCl (aba)          | min     |                | 0.4            | 43             |                |            |      |
| Absolute clock LOW pulse width   | tCL(abs)           | max     |                | 0.             | 57             |                | tCK(avg)   |      |
| Clask Pariod litter              | t IIT(por)         | min     | -70            | -40            | -34            | -30            |            |      |
| Clock Period Jitter              | tJIT(per)          | max     | 70             | 40             | 34             | 30             | ps         |      |
| Maximum Clock Jitter between two | ± 11 <b>⊤</b> (aa) | min     |                |                | -              |                | <b>D</b> C |      |
| consecutive clock cycles         | tJIT(cc)           | max     | 140            | 80             | 68             | 60             | ps         |      |

## Table — Clock timings

## Table — ZQ Calibration timings

| Parameter                       | Symbol   | Cymhol min/moy |     | LPDDR4 Data Rate |      |      |      |      |      |      |    | Nata |
|---------------------------------|----------|----------------|-----|------------------|------|------|------|------|------|------|----|------|
|                                 | Symbol   | min/max        | 533 | 1066             | 1600 | 2133 | 2667 | 3200 | 3733 | 4267 |    | Note |
| ZQ Calibration Time             | tZQCAL   | min            |     | 1                |      |      |      |      |      |      | us |      |
| ZQ Calibration Latch Quiet Time | tZQLAT   | min            |     | max(30ns, 8nCK)  |      |      |      |      |      |      | ns |      |
| Calibration Reset Time          | tZQRESET | min            |     | max(50ns, 3nCK)  |      |      |      |      |      |      | ns |      |



| Parameter  | Symbol           | min/<br>max | 533/<br>1066/<br>1600 | 2133/<br>2667                       | 3200/<br>3733/<br>4267 | Unit     | Note   |
|--|------------------|-------------|-----------------------|-------------------------------------|------------------------|----------|--------|
| Data Timing  |                  |             |                       |                                     |                        |          |        |
| DQS_t,DQS_c to DQ Skew   | tDQSQ            | max         |                       | 0.18                                |                        | UI       | 6      |
| DQ output hold time total from DQS_t, DQS_c<br>(DBI-Disabled)            | tQH              | min         | min                   | (tQSH, tC                           | SL)                    | ps       | 6      |
| DQ output window time total, per pin (DBI-<br>Disabled)                  | tQW_total        | min         | 0.75                  | 0.73                                | 0.70                   | UI       | 6,11   |
| DQS_t, DQS_c to DQ Skew total, per group, per<br>access<br>(DBI-Enabled) | tDQSQ_DBI        | max         |                       | 0.18                                |                        | UI       | 6      |
| DQ output hold time total from DQS_t, DQS_c<br>(DBlenabled)              | tQH_DBI          | min         | min(tQS               | H_DBI, tC                           | SL_DBI)                | ps       | 6      |
| DQ output window time total, per pin (DBI-<br>enabled)                   | tQW_total_DBI    | min         | 0.75                  | 0.73                                | 0.70                   | UI       | 6,11   |
| Read preamble  | tRPRE            | min         |                       | 1.8                                 |                        | tCK(avg) |        |
| Read postamble   | tRPST            | min         |                       | 0.4                                 |                        | tCK(avg) |        |
| Extended Read postamble  | tRPSTE           | min         |                       | 1.4                                 |                        | tCK(avg) |        |
| DQS Low-impedance time from CK_t, CK_c                                   | tLZ(DQS)         | min         |                       | K) + tDQS<br>E(Max) x<br>200ps      |                        | ps       |        |
| DQS High-impedance time from CK_t, CK_c                                  | tHZ(DQS)         | max         | + (BL/2 x             | K) + tDQS<br>tCK) +<br>∕lax) x tCł  | . ,                    | ps       |        |
| DQ Low-impedance time from CK_t, CK_c                                    | tLZ(DQ)          | min         | (RL x tC              | K) + tDQS<br>- 200ps                | SCK(Min)               | ps       |        |
| DQ High-impedance time from CK_t, CK_c                                   | tHZ(DQ)          | max         | + tDQS                | K) + tDQS<br>SQ(Max)+<br>CK) - 100p | (BL/2 x                | ps       |        |
| Data Strobe Timing   |                  |             |                       |                                     |                        |          |        |
| DOS output access time from CK/CK#                                       | tDQSCK           | min         |                       | 1.5                                 |                        | 50       | 1      |
| DQS output access time from CK/CK#                                       | IDQSCK           | max         |                       | 3.5                                 |                        | ns       | 1      |
| DQSCK Temperature Drift  | tDQSCK_temp      | max         |                       | 4                                   |                        | ps/°C    | 3      |
| DQSCK Volgate Drift  | tDQSCK_volt      | max         |                       | 7                                   |                        | ps/mV    | 2      |
| CK to DQS Rank to Rank variation   | tDQSCK_rank2rank | max         |                       | 1                                   |                        | ns       | 4,5    |
| DQS Output Low Pulse Width (DBI Disabled)                                | tQSL             | min         | tC                    | L(abs)-0.                           | 05                     | tCK(avg) | 9,11   |
| DQS Output High Pulse Width (DBI Disabled)                               | tQSH             | min         | tC                    | H(abs)-0.                           | 05                     | tCK(avg) | 10.,11 |
| DQS Output Low Pulse Width (DBI Enabled)                                 | tQSL_DBI         | min         | tC                    | L(abs)-0.0                          | )45                    | tCK(avg) | 9,11   |
| DQS Output High Pulse Width (DBI Enabled)                                | tQSH_DBI         |             | tCH(abs)-0.045        |                                     | tCK(avg)               | 10,11    |        |

Table — DQ Tx Voltage and Timings (Read Timing parameters)



- Includes DRAM process, voltage and temperature variation. It includes the AC noise impact for frequencies > 20 MHz and max voltage of 45 mV pk-pk from DC-20 MHz at a fixed temperature on the package. The volage supply noise must comply to the component Min-Max DC Operating conditions.
- 2. tDQSCK\_volt max delay variation as a function of DC voltage variation for VDDQ and VDD2. tDQSCK\_volt should be used to calculate timing variation due to VDDQ and VDD2 noise < 20 MHz. Host controller do not need to account for any variation due to VDDQ and VDD2 noise > 20 MHz. The voltage supply noise must comply to the component Min-Max DC Operating conditions. The voltage variation is defined as the Max[abs{tDQSCKmin@V1-tDQSCKmax@V2}, abs{tDQSCKmax@V1-tDQSCKmin@V2}] / abs{V1-V2}. For tester measurement VDDQ = VDD2 is assumed.
- 3. tDQSCK\_temp max delay variation as a function of Temperature.
- 4. The same voltage and temperature are applied to tDQS2CK\_rank2rank.
- 5. tDQSCK\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.
- 6. DQ to DQS differential jitter where the total includes the sum of deterministic and random timing terms for a specified BER.
- 7. The deterministic component of the total timing.
- 8. This parameter will be characterized and guaranteed by design.
- 9. tQSL describes the instantaneous differential output low pulse width on DQS\_t DQS\_c, as measured from on falling edge to the next consecutive rising edge.
- 10. tQSH describes the instantaneous differential output high pulse width on DQS\_t DQS\_c, as measured from on falling edge to thenext consecutive rising edge.
- 11. This parameter is function of input clock jitter. These values assume the min tCH(abs) and tCL(abs). When the input clock jitter min tCH(abs) and tCL(abs) is 0.44 or greater than tCK(avg), the min value of tQSL will be tCL(abs)-0.04 and tQSH will be tCH(abs)-0.04.
- 12. UI=tCK(avg)min/2



| Rx Mask voltage p-p totalVdIVW_totalmax140140140120mV1,2,3,Rx Mask voltage - deterministicVdIVW_dVmaxTBDTBDTBDTBDmV1,5,3Rx timing window total<br>(At VdIVW voltage levels)TdIVW_dVmaxTBDTBDTBDTBDmV1,5,5Rx deterministic timingTdIVW_totalmax0.220.220.250.25UI1,2,4,5Rx deterministic timingTdIVW_djmaxTBDTBDTBDUI1,5,6Rx timing window 1bit toggle<br>(At VdIVW voltage levels)TdIVW_1bitmaxTBDTBDTBDUI1,2,4,5DQ AC input pulse amplitude p-pVIHIL_ACmin180180170mV7,15DQ input pulse width (At Vcent_DQ)TdIPWmin0.450.450.45UI10DQ to DQS offsetTDQDQmax303030ps10DQ to DQS offset temperature variationTDQS2DQ_voltmax33333333ps/50mV12  |  | -                 |         |      |      |      |      |          |            |
|---|--|-------------------|---------|------|------|------|------|----------|------------|
| Rx Mask voltage - deterministicVdIVW_dVmaxTBDTBDTBDTBDTBDmV1.5Rx timing window total<br>(At VdIVW voltage levels)TdIVW_totalmax0.220.220.250.25UI1,2,4,Rx deterministic timingTdIVW_djmaxTBDTBDTBDTBDUI1,5Rx timing window 1bit toggle<br>(At VdIVW voltage levels)TdIVW_1bitmaxTBDTBDTBDTBDUI1,2,4,5DQ AC input pulse amplitude p-pVIHIL_ACmin1.80180180170mV7,15DQ input pulse width (At Vcent_DQ)TdIPWmin0.450.450.450.45UI10DQ to DQS offsetTDQQDQmax30303030ps99DQ to DQ soffsetTDQSDQ_tempmax30303030ps10DQ to DQS offset temperature variationTDQS2DQ_voltmax333333ps/50mV12DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17,18Write command to 1st DQS latching<br>transitiontDQSLmin0.4tCK(avg)CK(avg)0.5tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)tCK(avg)0.5tCK(avg)0.5tCK(avg)DQS falling edge hold time from CKtDSHmin0.4tCK(avg)tCK(avg)1.5tCK(avg) | Parameter                              | Symbol            | min/max |      |      |      | 4267 | Unit     | Note       |
| Rx timing window total<br>(At VdIVW voltage levels)TdIVW_totalmax $0.22$ $0.22$ $0.25$ $0.25$ UI $1.2,4,1,1,2,4,1,2,4,1,2,4,1,2,4,1,2,4,1,1,2,4,1,1,2,4,1,1,2,4,1,1,1,1$  | Rx Mask voltage p-p total              | VdIVW_total       | max     | 140  | 140  | 140  | 120  | mV       | 1,2,3,5    |
| $\begin{array}{ c c c c c c c c c c c c c c c c c c c$  | Rx Mask voltage - deterministic        | VdIVW_dV          | max     | TBD  | TBD  | TBD  | TBD  | mV       | 1,5        |
| Rx timing window 1bit toggle<br>(At VdIVW voltage levels)TdIVW_1bitmaxTBDTBDTBDTBDUI1,2,4,5DQ AC input pulse amplitude p-pVIHIL_ACmin180180180170mV7,15DQ input pulse width (At Vcent_DQ)TdIPWmin0.450.450.450.45UI10DQ to DQS offsetTDQS2DQmin200200200ps9DQ to DQS offsetTDQDQmax30303030ps10DQ to DQS offset temperature variationTDQS2DQ_tempmax303030ps10DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax333333ps/50mV12DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17,18Write command to 1st DQS latching<br>transitiontDQSHmin0.4tCK(avg)tCK(avg)DQS falling edge to CK setup timetDQSmin0.2tCK(avg)tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)QS falling edge hold time from CKtDYFSTmin0.4tCK(avg)0.5 tCK Write postambletWPSTEmin1.4tCK(avg)1.5 tCK Write postambletWPSTEmin1.4tCK(avg)1.5 tck Write postambletWPSTEmin1.4tCK(avg)                    |  | TdIVW_total       | max     | 0.22 | 0.22 | 0.25 | 0.25 | UI       | 1,2,4,5    |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $  | Rx deterministic timing                | TdIVW_dj          | max     | TBD  | TBD  | TBD  | TBD  | UI       | 1,5        |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $  |  | TdIVW_1bit        | max     | TBD  | TBD  | TBD  | TBD  | UI       | 1,2,4,5,14 |
| $\begin{array}{c c c c c c c c c c c c c c c c c c c $  | DQ AC input pulse amplitude p-p        | VIHIL_AC          | min     | 180  | 180  | 180  | 170  | mV       | 7,15       |
| DQ to DQS offsetTDQS2DQmax800800800800ps9DQ to DQ offsetTDQDQmax3030303030ps10DQ to DQS offset temperature variationTDQS2DQ_tempmax303030ps11DQ to DQS offset voltage variationTDQS2DQ_voltmax33333333ps/C11DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17,18Write command to 1st DQS latching<br>transitiontDQSSmin $0.4$ $0.4$ tCK(avg)tCK(avg)DQS input high-level widthtDQSLmin $0.4$ tCK(avg)tCK(avg)DQS falling edge to CK setup timetDSSmin $0.2$ tCK(avg)tCK(avg)DQS falling edge hold time from CKtDSHmin $0.4$ tCK(avg)tCK(avg)0.5 tCK Write postambletWPSTmin $0.4$ tCK(avg)tCK(avg)1.5 tCK Write postambletWPSTEmin $1.4$ tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin1111  | DQ input pulse width (At Vcent_DQ)     | TdIPW             | min     | 0.45 | 0.45 | 0.45 | 0.45 | UI       | 10         |
| max80090010DQ to DQS offset voltage variationTDQS2DQ_tempmax333333333333333333333333333333339s/50mV12DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17.18Write command to 1st DQS latching<br>transitiontDQSSmin $0.75$ tCK(avg)DQS input high-level widthtDQSHmin $0.4$ tCK(avg)DQS input low-level widthtDQSLmin $0.4$ tCK(avg)DQS falling edge to CK setup timetDSSmin $0.2$ tCK(avg)DQS falling edge hold time from CKtDSHmin $0.2$ tCK(avg)Urite preambletWPREmin $1.8$ tCK(avg)0.5 tCK Write postambletWPSTmin $1.4$ tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin $1.4$ tCK(avg)   |  | TDOCODO           | min     | 200  | 200  | 200  | 200  |          | 0          |
| DQ to DQS offset temperature variation         TDQS2DQ_temp         max         0.6         0.6         0.6         0.6         ps/C         11           DQ to DQS offset voltage variation         TDQS2DQ_volt         max         33         33         33         33         33         33         33         33         33         33         33         33         ps/50mV         12           DQ to DQS offset rank to rank         TDQS2DQ_rank2rank         max         200         200         200         ps         17,18           Write command to 1st DQS latching<br>transition         tDQSS         min         0.75         tCK(avg)   | DQ to DQS offset                       | TDQSZDQ           | max     | 800  | 800  | 800  | 800  | ps       | 9          |
| DQ to DQS offset voltage variationTDQS2DQ_voltmax3333333333ps/50mV12DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17,18Write command to 1st DQS latching<br>transition $tDQSS$ $min$ $0.75$ $tCK(avg)$ $tCK(avg)$ DQS input high-level widthtDQSHmin $0.4$ tCK(avg)DQS input low-level widthtDQSLmin $0.4$ tCK(avg)DQS falling edge to CK setup timetDSSmin $0.2$ tCK(avg)DQS falling edge hold time from CKtDSHmin $0.2$ tCK(avg)Write preambletWPREmin $0.4$ tCK(avg)0.5 tCK Write postambletWPSTmin $0.4$ tCK(avg)1.5 tCK Write postambletWPSTEmin $1.4$ tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin $1$ $1$ $1$  | DQ to DQ offset                        | TDQDQ             | max     | 30   | 30   | 30   | 30   | ps       | 10         |
| DQ to DQS offset rank to rankTDQS2DQ_rank2rankmax200200200ps17,18Write command to 1st DQS latching<br>transition $tDQSS$ $min$ $0.75$ $tCK(avg)$ $tCK(avg)$ DQS input high-level widthtDQSHmin $0.4$ $tCK(avg)$ DQS input low-level widthtDQSLmin $0.4$ $tCK(avg)$ DQS falling edge to CK setup timetDSSmin $0.2$ $tCK(avg)$ DQS falling edge hold time from CKtDSHmin $0.2$ $tCK(avg)$ Write preambletWPREmin $0.4$ $tCK(avg)$ 0.5 tCK Write postambletWPSTmin $0.4$ $tCK(avg)$ 1.5 tCK Write postambletWPSTEmin $1.4$ $tCK(avg)$ Input slew rate over VdIVW totalSRIN dIVWmin $1$ $1$ $1$   | DQ to DQS offset temperature variation | TDQS2DQ_temp      | max     | 0.6  | 0.6  | 0.6  | 0.6  | ps/°C    | 11         |
| Write command to 1st DQS latching<br>transitiontDQSSmin0.75<br>maxtCK(avg)DQS input high-level widthtDQSHmin0.4tCK(avg)DQS input low-level widthtDQSLmin0.4tCK(avg)DQS falling edge to CK setup timetDSSmin0.2tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)Write preambletWPREmin1.8tCK(avg)0.5 tCK Write postambletWPSTmin0.4tCK(avg)1.5 tCK Write postambletWPSTEmin1.4tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin111   | DQ to DQS offset voltage variation     | TDQS2DQ_volt      | max     | 33   | 33   | 33   | 33   | ps/50mV  | 12         |
| transitiontDQSSmax1.25tCK(avg)DQS input high-level widthtDQSHmin0.4tCK(avg)DQS input low-level widthtDQSLmin0.4tCK(avg)DQS falling edge to CK setup timetDSSmin0.2tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)Write preambletWPREmin1.8tCK(avg)0.5 tCK Write postambletWPSTmin0.4tCK(avg)1.5 tCK Write postambletWPSTEmin1.4tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin111   | DQ to DQS offset rank to rank          | TDQS2DQ_rank2rank | max     | 200  | 200  | 200  | 200  | ps       | 17,18      |
| transitionmax1.25C CDQS input high-level widthtDQSHmin0.4tCK(avg)DQS input low-level widthtDQSLmin0.4tCK(avg)DQS falling edge to CK setup timetDSSmin0.2tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)Write preambletWPREmin1.8tCK(avg)0.5 tCK Write postambletWPSTmin0.4tCK(avg)1.5 tCK Write postambletWPSTEmin1.4tCK(avg)Input slew rate over VdIVW totalSRIN dIVWmin111   | Write command to 1st DQS latching      | tDOSS             | min     |      | 0.   | 75   |      | tCK(ava) |            |
| DQS input low-level widthtDQSLmin0.4tCK(avg)DQS falling edge to CK setup timetDSSmin0.2tCK(avg)DQS falling edge hold time from CKtDSHmin0.2tCK(avg)Write preambletWPREmin1.8tCK(avg)0.5 tCK Write postambletWPSTmin0.4tCK(avg)1.5 tCK Write postambletWPSTEmin1.4tCK(avg)Input slew rate over VdIVW_totalSRIN_dIVWmin111  | transition                             | 10033             | max     |      | 1.   | 25   |      | iCr(avy) |            |
| DQS falling edge to CK setup time       tDSS       min       0.2       tCK(avg)         DQS falling edge hold time from CK       tDSH       min       0.2       tCK(avg)         Write preamble       tWPRE       min       1.8       tCK(avg)         0.5 tCK Write postamble       tWPST       min       0.4       tCK(avg)         1.5 tCK Write postamble       tWPSTE       min       1.4       tCK(avg)         Input slew rate over VdIVW_total       SRIN_dIVW       min       1       1       1       1  | DQS input high-level width             | tDQSH             | min     |      | 0    | .4   |      | tCK(avg) |            |
| DQS falling edge hold time from CK       tDSH       min       0.2       tCK(avg)         Write preamble       tWPRE       min       1.8       tCK(avg)         0.5 tCK Write postamble       tWPST       min       0.4       tCK(avg)         1.5 tCK Write postamble       tWPSTE       min       1.4       tCK(avg)         Input slew rate over VdIVW_total       SRIN_dIVW       min       1       1       1       1  | DQS input low-level width              | tDQSL             | min     |      | 0    | .4   |      | tCK(avg) |            |
| Write preamble     tWPRE     min     1.8     tCK(avg)       0.5 tCK Write postamble     tWPST     min     0.4     tCK(avg)       1.5 tCK Write postamble     tWPSTE     min     1.4     tCK(avg)       Input slew rate over VdIVW_total     SRIN_dIVW     min     1     1     1     1   | DQS falling edge to CK setup time      | tDSS              | min     |      | 0    | .2   |      | tCK(avg) |            |
| 0.5 tCK Write postamble     tWPST     min     0.4     tCK(avg)       1.5 tCK Write postamble     tWPSTE     min     1.4     tCK(avg)       Input slew rate over VdIVW_total     SRIN_dIVW     min     1     1     1     1   | DQS falling edge hold time from CK     | tDSH              | min     |      | 0    | .2   |      | tCK(avg) |            |
| 1.5 tCK Write postamble     tWPSTE     min     1.4     tCK(avg)       Input slew rate over VdIVW_total     SRIN_dIVW     min     1     1     1     1  | Write preamble                         | tWPRE             | min     |      | 1    | .8   |      | tCK(avg) |            |
| Input slew rate over VdIVW_totalSRIN_dIVWmin11_1_1V/ns13  | 0.5 tCK Write postamble                | tWPST             | min     |      | 0    | .4   |      | tCK(avg) |            |
| Input slew rate over VdIVW total SRIN dIVW V/ns 13  | 1.5 tCK Write postamble                | tWPSTE            | min     |      | 1    | .4   |      | tCK(avg) |            |
|   | Input slew rate over \/dl\/\// total   |                   | min     | 1    | 1    | 1    | 1    | V/ne     | 13         |
|   |  |                   | max     | 7    | 7    | 7    | 7    | V/115    | 10         |

1. Data Rx mask voltage and timing parameters are applied per pin and includes the DRAM DQ to DQS voltage AC noise impact for frequencies >250KHz at a fixed temperature on the package. The voltage supply noise must comply to the component Min-Max DC operating conditions.

2. The design specification is a BER <tbd. The BER will be characterized and extrapolated if necessary using a dual dirac method.

3. Rx mask voltage VdIVW total(max) must be centered around Vcent\_DQ(pin\_mid).

4. Rx differential DQ to DQS jitter total timing window at the VdIVW voltage levels.

5. Defined over the DQ internal Vref range. The Rx mask at the pin must be within the internal Vref DQ range irrespective of the input signal common mode.

6. Deterministic component of the total Rx mask voltage or timing. Parameter will be characterized and guaranteed by design. Measurement method TBD



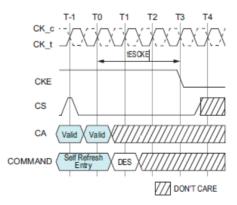
- 7. DQ only input pulse amplitude into the receiver must meet or exceed VIHL AC at any point over the total UI. No timing requirement above level. VIHL AC is the peak to peak voltage centered around Vcent\_DQ(pin\_mid) such that IHL\_AC/2 min must be met both above and below Vcent\_DQ.
- 8. DQ only minimum input pulse width defined at the Vcent\_DQ(pin\_mid).
- 9. DQ to DQS offset is within byte from DRAM pin to DRAM internal latch. Includes all DRAM process, voltage and temperature variation.
- 10. DQ to DQ offset defined within byte from DRAM pin to DRAM internal latch for a given component.
- 11. TDQS2DQ max delay variation as a function of temperature.
- 12. TDQS2DQ max delay variation as a function of the DC voltage variation for VDDQ and VDD2.
- 13. Input slew rate over VdIVW Mask centered at Vcent\_DQ(pin\_mid).
- 14. Rx mask defined for a one pin toggling with other DQ signals in a steady state.
- 15. VIHL\_AC does not have to be met when no transitions are occurring.
- 16. UI=tCK(avg)min/2
- 17. The same voltage and temperature are applied to tDQS2DQ\_rank2rank
- 18. tDQS2DQ\_rank2rank parameter is applied to multi-ranks per byte lane within a package consisting of the same design dies.
- A. The following Rx voltage and timing requirements apply for all DQ operating frequencies at or below 1600 for all speed bins. The timing parameters in UI can be converted to absolute time values where tck(avg)min/2= 625ps for DQ=1600. For example the TdIVW\_total(ps) =0.22\*625ps= 137.5ps.

### Table — Self-Refresh Timing Parameters

| Parameter                                      | Cumbal |         | Data Rate                 |      |      |      |      |      |      | Linit | Nata |
|--|--------|---------|---------------------------|------|------|------|------|------|------|-------|------|
|  | Symbol | min/max | 533 1066                  | 1600 | 2133 | 2667 | 3200 | 3733 | 4267 | Unit  | Note |
| Delay from Self Refresh Entry to CKE Input Low | tESCKE | min     | max(1.75ns,3tCK)          |      |      |      | nCK  | 1    |      |       |      |
| Minimum Self-Refresh Time (Entry to Exit)      | tSR    | min     | max(15ns, 3nCK)           |      |      |      | ns   | 1    |      |       |      |
| Self refresh exit to next valid command delay  | tXSR   | min     | max(tRFCab + 7.5ns, 2nCK) |      |      |      | ns   | 1,2  |      |       |      |

Note

 Delay time has to satisfy both analog time(ns) and clock count(tCK). It means that tESCKE will not expire until CK has toggled through at least 3 full cycles (3 \*tCK) and 1.75ns has transpired. The case which 3tCK is applied to is shown below.



2. MRR-1, CAS-2, SRX, MPC, MRW-1, and MRW-2 commands (except PASR bank/segment setting) are only allowed during this period.



| Parameter                         | Symbol    | min/<br>max | DQ-1333 <sup>A)</sup> | DQ-1600/<br>1867 | DQ-3200 | DQ-4266 | Unit | Note    |
|-----------------------------------|-----------|-------------|-----------------------|------------------|---------|---------|------|---------|
| Rx Mask voltage p-p               | VcIVW     | max         | 175                   | 175              | 155     | 145     | mV   | 1,2,4   |
| Rx timing window                  | tcIVW     | max         | 0.3                   | 0.3              | 0.3     | 0.3     | UI   | 1,2,3,4 |
| CA AC input pulse amplitude pk-pk | VIHL_AC   | min         | 210                   | 210              | 190     | 180     | mV   | 5,8     |
| CA input pulse width              | TcIPW     | min         | 0.55                  | 0.55             | 0.6     | 0.6     | UI   | 6       |
|                                   |           | min         | 1                     | 1                | 1       | 1       | V/no | 7       |
| Input slew rate over VcIVW        | SRIN_cIVW | max         | 7                     | 7                | 7       | 7       | V/ns | 1       |

#### Table — Command Address Input Parameters

Notes:

1. CA Rx mask voltage and timing parameters at the pin including voltage and temperature drift.

2. Rx mask voltage VcIVW total(max) must be centered around Vcent\_CA(pin mid).

- 3. Rx differential CA to CK jitter total timing window at the VcIVW voltage levels.
- 4. Defined over the CA internal Vref range. The Rx mask at the pin must be within the internal Vref CA range irrespective of the input signal common mode.
- 5. CA only input pulse signal amplitude into the receiver must meet or exceed VIHL AC at any point over the total UI. No timing requirement above level. VIHL AC is the peak to peak voltage centered around Vcent\_CA(pin mid) such that VIHL\_AC/2 min must be met both above and below Vcent\_CA.
- 6. CA only minimum input pulse width defined at the Vcent\_CA(pin mid).
- 7. Input slew rate over VcIVW Mask centered at Vcent\_CA(pin mid).
- 8. VIHL\_AC does not have to be met when no transitions are occurring.
- 9. UI=tCK(avg)min
- A. The following Rx voltage and timing requirements apply for DQ operating frequencies at or below 1333 for all speed bins. The timing parameters in UI can be converted to absolute time values where tck(avg)min= 1.5ns for DQ=1333. For example the TclVW(ps) = 0.3\*1.5ns=450ps.

| Parameter                                   | Question | min/ |        |      |      | Data | Rate |      |      |      | l lmit | Niete |
|---|----------|------|--------|------|------|------|------|------|------|------|--------|-------|
|   | Symbol   | max  | 533    | 1066 | 1600 | 2133 | 2667 | 3200 | 3733 | 4267 | Unit   | Note  |
| Clock Cycle Time                            | tCKb     |      | min 18 |      |      |      |      |      |      |      |        |       |
| Clock Cycle Time                            | ICRD     | max  |        |      |      | 100  |      |      |      |      | ns     |       |
| DQS Output Data Access Time from            | tDQSCKb  | min  |        |      |      |      | l    |      |      |      | nc     |       |
| CK/CK#                                      | IDQOUND  | max  |        |      |      | 1    | 0    |      |      |      | ns     |       |
| Data Strobe Edge to Output Data Edge tDQSQb | tDQSQb   | max  |        |      |      | 1.   | 2    |      |      |      | ns     |       |

#### Table — Boot Parameters



| Parameter   | Symbol | min/ |     |                  |      | Data    | Rate    |      |      |      | Unit | Note |
|---|--------|------|-----|------------------|------|---------|---------|------|------|------|------|------|
|   | Symbol | max  | 533 | 1066             | 1600 | 2133    | 2667    | 3200 | 3733 | 4267 | Unit | NOLE |
| Additional time after tXP has expired<br>until the MRR<br>command may be issued | tMRRI  | min  |     |                  |      | tRCD +  | - 3nCK  |      |      |      | ns   |      |
| MODE REGISTER Write command<br>period   | tMRW   | min  |     | max(10ns, 10nCK) |      |         |         |      |      |      |      |      |
| MODE REGISTER Read command<br>period  | tMRR   | min  |     | 8 r              |      |         |         |      |      |      |      |      |
| Mode Register Write Set Command<br>Delay  | tMRD   | min  |     |                  | ma   | ax(14ns | s, 10nC | K)   |      |      | ns   |      |

## Table — Mode Register Parameters

### Table — VRCG Enable/Disable Timing

| Parameter                              | Symbol        | min/ | Data Rate |      |      |      |      |      |      |  | Unit | Note |
|--|---------------|------|-----------|------|------|------|------|------|------|--|------|------|
|  | Symbol        | max  | 533       | 1066 | 1600 | 2133 | 2667 | 3200 | 3733 |  | Onit | NOLE |
| VREF high current mode<br>enable time  | tVRCG_Enable  | max  |           |      |      | 20   | 0    |      |      |  | ns   |      |
| VREF high current mode<br>disable time | tVRCG_Disable | max  |           |      |      | 10   | 0    |      |      |  | ns   |      |



| Parameter   | Symbol          | min/<br>max | Data Rate           533         1066         1600         2133         2667         3200         3733         4267 | Unit | Note |
|---|-----------------|-------------|--|------|------|
| Valid Clock Requirement after CKE Input Low                       | tCKELCK         | min         | max(5ns, 5nCK)   | -    |      |
| Data Setup for Vref Training Mode                                 | tDStrain        | min         | 2  | ns   |      |
| Data Hold for Vref Training Mode                                  | tDHtrain        | min         | 2  | ns   |      |
| Asynchronous Data Read  | tADR            | max         | 20   | ns   |      |
| CA Bus Training Command to CA Bus<br>Training command<br>Delay    | tCACD           | min         | RU(tADR/tCK)   | tCK  | 2    |
| Valid Strobe Requirement before CKE Low                           | tDQSCKE         | min         | 10   | ns   | 1    |
| First CA Bus Training Command Following<br>CKE Low                | tCAENT          | min         | 250  | ns   |      |
| Vref Step Time – multiple steps                                   | tVref_long      | max         | 250  | ns   |      |
| Vref Step Time – one step   | tVref_short     | max         | 80   | ns   |      |
| Valid Clock Requirement before CS High                            | tCKPRECS        | min         | 2*tCK + tXP  | -    |      |
| Valid Clock Requirement after CS High                             | tCKPSTCS        | min         | max(7.5ns, 5nCK)   | -    |      |
| Minimum delay from CS to DQS toggle in<br>command<br>bus training | tCS_Vref        | min         | 2  | tCK  |      |
| Minimum delay from CKE High to Strobe High<br>Impedance           | tCKEHDQ<br>S    | min         | 10   | ns   |      |
| Valid Clock Requirement before CKE Input<br>High                  | tCKCKEH         | min         | max(1.75ns, 3nCK)  | -    |      |
| CA Bus Training CKE High to DQ Tri-state                          | tMRZ            | min         | 1.5  | ns   |      |
| ODT turn-on latency from CKE                                      | tCKELODT<br>on  | min         | 20   | ns   |      |
| ODT turn-off latency from CKE                                     | tCKELODT<br>off | min         | 20   | ns   |      |

#### Table — Command Bus Training Parameters

Notes:

1. DQS\_t has to retain a low level during tDQSCKE period, as well as DQS\_c has to retain a high level.

2. If tCACD is violated, the data for samples which violate tCACD will not be available, except for the last sample (where tCACD after this sample is met). Valid data for the last sample will be available after tADR.



| Parameter  | Cumphical    | min/   |      |      | Data     | Rate      |      |      | 1.1.0.14 | Nate |
|--|--------------|--------|------|------|----------|-----------|------|------|----------|------|
| T didifictor   | Symbol       | max    | 1600 | 2133 | 2400     | 3200      | 3733 | 4267 | Unit     | Note |
| DQS_t/DQS_c delay after write leveling mode is programmed                          | tWLDQSEN     | min 20 |      |      |          |           |      |      | tCK      |      |
| Vrite preamble for Write     tWLWPRE     min     20                                |              |        |      |      |          |           | tCK  |      |          |      |
| First DQS_t/DQS_c edge after<br>vrite leveling mode is tWLMRD min 40<br>programmed |              |        |      |      |          | tCK       |      |      |          |      |
| Write leveling output delay  | tWLO         | min    |      |      | (        | )         |      |      | ns       |      |
| while leveling output delay  | 11120        | max    |      |      | 113      |           |      |      |          |      |
| Valid Clock Requirement<br>before DQS Toggle                                       | tCKPRDQS     | min    |      |      | max(7.5n | ıs, 4nCK) |      |      |          |      |
| Valid Clock Requirement after<br>DQS Toggle  | tCKPSTDQS    | min    |      |      | max(7.5n | is, 4nCK) |      |      |          |      |
| Write leveling hold time   | tWLH         | min    | 150  | 100  | 100      | 75        | 62.5 | 50   | ps       | 1,2  |
| Write leveling setup time  | tWLS         | min    | 150  | 100  | 100      | 75        | 62.5 | 50   | ps       | 1,2  |
| Write leveling invalid window  | tWLIVW_Total | min    | 240  | 160  | 160      | 120       | 105  | 90   | ps       | 1,2  |

#### Table — Write Leveling Parameters

Notes:

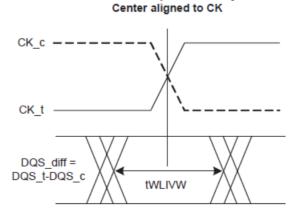
1. In addition to the traditional setup and hold time specifications above, there is value in a invalid window based specification for write-leveling training. As the training is based on each device, worst case process skews for setup and hold do not make sense to close timing between CK and DQS.

 tWLIVW\_Total is defined in a similar manner to tdIVW\_Total, except that here it is a DQS invalid window with respect to CK. This would need to account for all VT (voltage and temperature) drift terms between CK and DQS within the DRAM that affect the write-leveling invalid window.

The DQS input mask for timing with respect to CK is shown in the following figure. The "total" mask (TdiVW\_total) defines the time the input signal must not encroach in order for the DQS input to be successfully captured by CK with a BER of lower than tbd. The mask is a receiver property and it is not the valid data-eye.

### Figure — DQS\_t/DQS\_c and CK\_t/CK\_c at DRAM Latch

Internal Composite DQS Eye





| Parameter                                   | Symbol | Symbol | Symbol | min/             |      |      |      | Data | Rate |      |      |      | Linit | Note |
|---|--------|--------|--------|------------------|------|------|------|------|------|------|------|------|-------|------|
|   | Symbol | max    | 533    | 1066             | 1600 | 2133 | 2667 | 3200 | 3733 | 4267 | Unit | Note |       |      |
| Delay from MRW command to<br>DQS Driven out | tSDO   | max    |        | max(12nCK, 20ns) |      |      |      |      |      | ns   | 1    |      |       |      |

#### Table — Read Preamble Training Timings

#### Table — MPC [Write FIFO] AC Timing

| Parameter  | Symbol | min/ |     |      |      | Data   | Rate |      |      |      | Linit | Noto |
|--|--------|------|-----|------|------|--------|------|------|------|------|-------|------|
|  | Symbol | max  | 533 | 1066 | 1600 | 2133   | 2667 | 3200 | 3733 | 4267 | Unit  | Note |
| Additional time after tXP has<br>expired until MPC [Write FIFO]<br>command may be issued | tMPCWR | min  |     |      |      | tRCD + | 3nCK |      |      |      |       |      |

#### Table — DQS Interval Oscillator AC Timing

| Parameter  | Symbol | min/max | Value          | Unit | Note |
|--|--------|---------|----------------|------|------|
| Delay time from OSC stop to<br>Mode Register Readout | tOSCO  | min     | max(40ns,8nCK) | ns   |      |

#### Table — Frequency Set Point Timing

| Parameter  | Symbol     | min/<br>max | 533              | 1066 |      |  | a Rate<br>3 2667 3200 3733 4267 |      |      | Unit | Not<br>e |   |
|--|------------|-------------|------------------|------|------|--|---------------------------------|------|------|------|----------|---|
|  |            |             | 555              | 1000 | 1000 |  |                                 | 5200 | 5755 | 4207 |          | - |
|  | tFC_Short  | min         | า 200            |      |      |  |                                 |      |      | ns   | 1        |   |
| Frequency Set Point Switching Time                                     | tFC_Middle | min         | 200              |      |      |  |                                 |      |      | ns   | 1        |   |
|  | tFC_Long   | min         |                  | 250  |      |  |                                 |      |      |      |          | 1 |
| Valid Clock Requirement after entering FSP change                      | tCKFSPE    | min         |                  |      |      |  |                                 |      |      |      |          |   |
| Valid Clock Requirement before 1st valid<br>ommand<br>after FSP change | tCKFSPX    | min         | max(7.5ns, 4nCK) |      |      |  |                                 |      |      |      |          |   |

Notes:

1. Frequency Set Point Switching Time depends on value of Vref(ca) setting: MR12 OP[5:0] and Vref(ca) Range: MR12 OP[6] of FSPOP

0 and 1. The details are shown in Table "tFC value maping".

Additionally change of Frequency Set Point may affect Vref(dq) setting. Setting time of Vref(dq) level is same as Vref(ca) level.



| Parameter                | Symbol | min/max | LPDDR4-1600/1866/2133/2400/3200/4267 | Unit | Note |
|--------------------------|--------|---------|--------------------------------------|------|------|
| ODT CA Value Update Time | tODTUP | min     | RU(20ns/tCK,avg)                     |      |      |

### Table — CA ODT setting timing

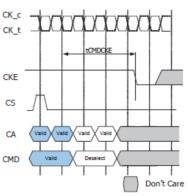
#### Table — Power Down timing

| Parameter   | Symbol   | min/ |                   |                  |      | Data    | Rate    |               |      | I    | Unit | Not |
|---|----------|------|-------------------|------------------|------|---------|---------|---------------|------|------|------|-----|
|   | Gymbol   | max  | 533               | 1066             | 1600 | 2133    | 2667    | 3200          | 3733 | 4267 | Onit | е   |
| CKE minimum pulse width (HIGH and LOW pulse width)  | tCKE     | min  |                   | Max(7.5ns,4nCK)  |      |         |         |               |      |      | -    |     |
| Delay from valid command to CKE input<br>LOW  | tCMDCKE  | min  |                   | Max(1.75ns,3nCK) |      |         |         |               |      |      | ns   | 1   |
| Valid Clock Requirement after CKE Input low   | tCKELCK  | min  |                   |                  | М    | ax(5ns  | s,5nCł  | <)            |      |      | ns   | 1   |
| Valid CS Requirement before CKE Input<br>Low  | tCSCKE   | min  |                   |                  |      | 1.7     | 75      |               |      |      | ns   |     |
| Valid CS Requirement after CKE Input<br>low   | tCKELCS  | min  |                   |                  | M    | ax(5ns  | , 5nCl  | <b>&lt;</b> ) |      | ns   |      |     |
| Valid Clock Requirement before CKE<br>Input High  | tCKCKEH  | min  |                   |                  | Мах  | k(1.75r | ns, 3n( | CK)           | )    |      |      | 1   |
| Exit power- down to next valid command delay  | tXP      | min  |                   |                  | Ма   | x(7.5n  | s, 5nC  | CK)           |      |      | ns   | 1   |
| Valid CS Requirement before CKE Input<br>High   | tCSCKEH  | min  |                   |                  |      | 1.7     | 75      |               |      |      | ns   |     |
| Valid CS Requirement after CKE Input<br>High  | tCKEHCS  | min  |                   |                  | Ма   | x(7.5n  | s, 5nC  | CK)           |      |      | ns   | 1   |
| Valid Clock and CS Requirement after<br>CKE Input low after MRW Command                     | tMRWCKEL | min  | Max(14ns, 10nCK)  |                  |      |         |         |               |      | ns   | 1    |     |
| Valid Clock and CS Requirement after<br>CKE Input low after ZQ Calibration Start<br>Command | tZQCKE   | min  | Max(1.75ns, 3nCK) |                  |      |         |         |               | ns   | 1    |      |     |

Notes:

1. Delay time has to satisfy both analog time(ns) and clock count(nCK).

For example, tCMDCKE will not expire until CK has toggled through at least 3 full cycles (3 \*tCK) and 3.75ns has transpired. The case which 3nCK is applied to is shown below.



### Figure — tCMDCKE Timing



| Parameter                | Symbol    | LPDI | DR4 | Unit | Note |
|--------------------------|-----------|------|-----|------|------|
|                          | Symbol    | Min  | Max | Unit | Note |
| PPR Programming Time     | tPGM      | 1000 | -   | ms   |      |
| PPR Exit Time            | tPGM_Exit | 15   | -   | ns   |      |
| New Address Setting Time | tPGMPST   | 50   | -   | us   |      |

### Table — PPR Timing Parameters

### Table — Temperature Derating for AC timing

| Parameter  | Sumbol  | min/ |              |      |      | Data  | Rate  |      |      |      | Linit | Note |
|--|---------|------|--------------|------|------|-------|-------|------|------|------|-------|------|
|  | Symbol  | max  | 533          | 1066 | 1600 | 2133  | 2667  | 3200 | 3733 | 4267 |       | note |
| DQS Output access time from<br>CK_t/CK_c (derated) | tDQSCKd | max  | 3600         |      |      |       |       |      |      |      | ps    | 1    |
| RAS-to-CAS delay (derated)                         | tRCDd   | min  | tRCD + 1.875 |      |      |       |       |      |      |      | ns    | 1    |
| Activate-to-Activate command period (derated)      | tRCd    | min  |              |      |      | tRC + | 3.75  |      |      |      | ns    | 1    |
| Row active time (derated)                          | tRASd   | min  |              |      | t    | RAS + | 1.875 |      |      |      | ns    | 1    |
| Row precharge time (derated)                       | tRPd    | min  | tRP + 1.875  |      |      |       |       |      |      | ns   | 1     |      |
| Active bank A to Active bank B (derated)           | tRRDd   | min  | tRRD + 1.875 |      |      |       |       |      |      | ns   | 1     |      |

Notes:

1. Timing derating applies for operation at 85°C to 95°C



## 1.3.4 Truth Tables

Operation or timing that is not specified is illegal, and after such an event, in order to guarantee proper operation, the LPDDR4 device must be powered down and then restarted through the specified initialization sequence before normal operation can continue.

| Table — Command Truth Table              |                  |     |     |     |        |     |     |        |            |  |
|--|------------------|-----|-----|-----|--------|-----|-----|--------|------------|--|
| Command                                  | SDR Command Pins |     | r   |     | Pins ( |     |     | CK_ted | Notes      |  |
|  | CS_n             | CA0 | CA1 | CA2 | CA3    | CA4 | CA5 | ge     | Notes      |  |
| Deselect (DES)                           | L                |     |     | )   | X      |     |     | R1     | 1,2        |  |
| Multi Purpose Command (MPC)              | Н                | L   | L   | L   | L      | L   | OP6 | R1     | 1,2,9      |  |
|  | L                | OP0 | OP1 | OP2 | OP3    | OP4 | OP5 | R2     | 1,2,9      |  |
| Precharge (Per Bank, All Bank)           | Н                | L   | L   | L   | L      | Н   | AB  | R1     | 1,2,3,4    |  |
|  | L                | BA0 | BA1 | BA2 | V      | V   | V   | R2     | 1,2,3,4    |  |
| Refresh (Per Bank, All Bank)             | Н                | L   | L   | L   | Н      | L   | AB  | R1     | 1,2,3,4    |  |
|  | L                | BA0 | BA1 | BA2 | V      | V   | V   | R2     | 1,2,0,4    |  |
| Self Refresh Entry                       | Н                | L   | L   | L   | Н      | Н   | V   | R1     | 1,2        |  |
|  | L                |     |     | ١   | V      |     |     | R2     | 1,2        |  |
| Write-1                                  | Н                | L   | L   | н   | L      | L   | BL  | R1     | 1,2,3,6,7, |  |
|  | L                | BA0 | BA1 | BA2 | V      | C9  | AP  | R2     | 9          |  |
| Self Refresh Exit                        | Н                | L   | L   | Н   | L      | Н   | V   | R1     | 1,2        |  |
|  | L                |     |     | ١   | V      |     |     | R2     | 1,2        |  |
| Mask Write-1                             | Н                | L   | L   | н   | н      | L   | L   | R1     | 1,2,3,5,6, |  |
|  | L                | BA0 | BA1 | BA2 | V      | C9  | AP  | R2     | 9          |  |
| RFU                                      | Н                | L   | L   | н   | Н      | Н   | V   | R1     | 1,2        |  |
|  | L                |     |     | ١   | V      |     |     | R2     | 1,2        |  |
| Read-1                                   | Н                | L   | Н   | L   | L      | L   | BL  | R1     | 1,2,3,6,7, |  |
|  | L                | BA0 | BA1 | BA2 | V      | C9  | AP  | R2     | 9          |  |
| CAS-2 (Write-2 or Mask Write-2 or Read-2 | Н                | L   | Н   | L   | L      | н   | C8  | R1     | 1,8,9      |  |
| or MRR-2)                                | L                | C2  | C3  | C4  | C5     | C6  | C7  | R2     | 1,0,9      |  |
| RFU                                      | Н                | L   | Н   | L   | Н      | L   | V   | R1     | 1,2        |  |
|  | L                |     |     | ١   | V      |     |     | R2     | 1,2        |  |
| RFU                                      | Н                | L   | Н   | L   | Н      | Н   | V   | R1     | 1.0        |  |
| KF U                                     | L                |     |     | ١   | V      |     |     | R2     | 1,2        |  |
| MRW-1                                    | Н                | L   | Н   | Н   | L      | L   | OP7 | R1     | 1 2 1 1    |  |
|  | L                | MA0 | MA1 | MA2 | MA3    | MA4 | MA5 | R2     | 1,2,11     |  |
| MRW-2                                    | Н                | L   | Н   | Н   | L      | Н   | OP6 | R1     | 1 2 1 1    |  |
|  | L                | OP0 | OP1 | OP2 | OP3    | OP4 | OP5 | R2     | 1,2,11     |  |
|  | Н                | L   | Н   | Н   | Н      | L   | V   | R1     | 1 2 1 2    |  |
| MRR-1                                    | L                | MA0 | MA1 | MA2 | MA3    | MA4 | MA5 | R2     | 1,2,12     |  |

## able — Command Truth Table

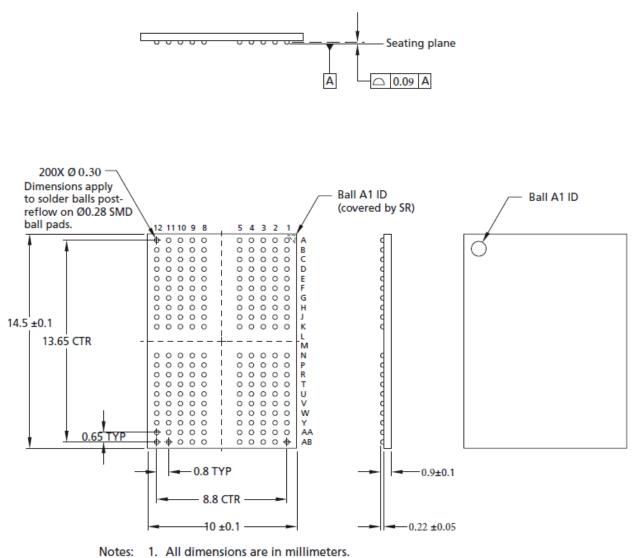
Kingston<sup>®</sup>

| RFU         | Н | L   | Н   | Н   | Н   | Н   | V   | R1 | 1.0      |
|-------------|---|-----|-----|-----|-----|-----|-----|----|----------|
|             | L |     |     | ١   | /   |     |     | R2 | 1,2      |
| Activate-1  | Н | Н   | L   | R12 | R13 | R14 | R15 | R1 | 1 2 2 10 |
|             | L | BA0 | BA1 | BA2 | V   | R10 | R11 | R2 | 1,2,3,10 |
| Activiste 2 | Н | Н   | н   | R6  | R7  | R8  | R9  | R1 | 1 10     |
| Activate-2  | L | R0  | R1  | R2  | R3  | R4  | R5  | R2 | 1,10     |

- 1. All LPDDR4 commands except for Deselect are 2 clock cycle long and defined by states of CS and CA[5:0] at the first rising edge of clock. Deselect command is 1 clock cycle long.
- 2. "V" means "H" or "L" (a defined logic level). "X" means don't care in which case CS, CK\_t, CK\_c and CA[5:0] can be floated.
- 3. Bank addresses BA[2:0] determine which bank is to be operated upon.
- 4. AB "HIGH" during Precharge or Refresh command indicates that command must be applied to all banks and bank address is a don't care.
- 5. Mask Write-1 command supports only BL 16. For Mark Write-1 comamnd, CA5 must be driven LOW on first rising clock cycle (R1).
- 6. AP "HIGH" during Write-1, Mask Write-1 or Read-1 commands indicates that an auto-precharge will occur to the bank associated with the Write, Mask Write or Read command.
- 7. If Burst Length on-the-fly is enabled, BL "HIGH" during Write-1 or Read-1 command indicates that Burst Length should be set on-the-Fly to BL=32. BL "LOW" during Write-1 or Read-1 command indicates that Burst Length should be set on-the-fly to BL=16. If Burst Length on-the-fly is disabled, then BL must be driven to defined logic level "H" or "L".
- For CAS-2 commands (Write-2 or Mask Write-2 or Read-2 or MRR-2 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration), C[1:0] are not transmitted on the CA[5:0] bus and are assumed to be zero. Note that for CAS-2 Write-2 or CAS-2 Mask Write-2 command, C[3:2] must be driven LOW.
- 9. Write-1 or Mask Write-1 or Read-1 or Mode Register Read-1 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration) command must be immediately followed by CAS-2 command consecutively without any other command in between. Write-1 or Mask Write-1 or Read-1 or Mode Register Read-1 or MPC (Only Write FIFO, Read FIFO & Read DQ Calibration) command must be issued first before issuing CAS-2 command. MPC (Only Start & Stop DQS Oscillator, Start & Latch ZQ Calibration) commands do not require CAS-2 command; they require two additional DES or NOP commands consecutively before issuing any other commands.
- 10. Activate-1 command must be immediately followed by Activate-2 command consecutively without any other command in between. Activate-1 command must be issued first before issuing Activate-2 command. Once Activate-1 command is issued, Activate-2 command must be issued before issuing another Activate-1 command.
- 11. MRW-1 command must be immediately followed by MRW-2 command consecutively without any other command in between. MRW-1 command must be issued first before issuing MRW-2 command.
- 12. MRR-1 command must be immediately followed by CAS-2 command consecutively without any other command in between. MRR-1 command must be issued first before issuing CAS-2 command.



## 2. Package Mechanical



### 2.1. 200 ball FBGA (10 x 14.5 x 1.0mm max)

Dies. 1. All dimensions are in minimeters.

2. Solder ball composition: SAC302 with NiAu pads (96.8% Sn, 3Ag, 0.2% Cu).

3. The package height does not include room temperature warpage.



## 3. Ball Assignment

3.1. 200 balls assignment

|               |    | 1    | 2         | 3        | 4      | 0.80 m<br>s | m Pitch<br>د |
|---------------|----|------|-----------|----------|--------|-------------|--------------|
|               | A  | DNU  | DNU       | VSS      | VDD2   | ZQO         |              |
|               | в  | DNU  | DQ0_A     | VDDQ     | DQ7_A  | VDDQ        |              |
|               | с  | VSS  | DQ1_A     | DMI0_A   | DQ6_A  | VSS         |              |
|               | D  | VDDQ | VSS       | DQS0_t_A | VSS    | VDDQ        |              |
|               | E  | VSS  | DQ2_A     | DQS0_c_A | DQ5_A  | VSS         |              |
|               | F  | VDD1 | DQ3_A     | VDDQ     | DQ4_A  | VDD2        |              |
|               | G  | VSS  | ODT(ca)_A | VSS      | VDD1   | VSS         |              |
|               | н  | VDD2 | CA0_A     | CS1_A    | CSO_A  | VDD2        |              |
|               | J  | VSS  | CA1_A     | VSS      | CKE0_A | CKE1_A      |              |
|               | к  | VDD2 | VSS       | VDD2     | VSS    | CS2_A       |              |
|               | M  |      |           |          |        |             |              |
| itch          | N  | VDD2 | VSS       | VDD2     | VSS    | CS2_B       |              |
| 0.65 mm Pitch | P  | VSS  | CA1_B     | VSS      | CKE0_B | CKE1_B      |              |
| 0.65          | R  | VDD2 | CA0_B     | CS1_B    | CS0_B  | VDD2        |              |
|               | т  | VSS  | ODT(ca)_B | VSS      | VDD1   | VSS         |              |
|               | U  | VDD1 | DQ3_B     | VDDQ     | DQ4_B  | VDD2        |              |
|               | ۷  | VSS  | DQ2_B     | DQS0_c_B | DQ5_B  | VSS         |              |
|               | w  | VDDQ | VSS       | DQS0_t_B | VSS    | VDDQ        |              |
|               | Y  | VSS  | DQ1_B     | DMI0_B   | DQ6_B  | VSS         |              |
|               | AA | DNU  | DQ0_B     | VDDQ     | DQ7_B  | VDDQ        |              |
|               | AB | DNU  | DNU       | VSS      | VDD2   | VSS         |              |

| 8      | 9      | 10       | 11     | 12   |
|--------|--------|----------|--------|------|
| ZQ1    | VDD2   | VSS      | DNU    | DNU  |
| VDDQ   | DQ15_A | VDDQ     | DQ8_A  | DNU  |
| VSS    | DQ14_A | DMI1_A   | DQ9_A  | VSS  |
| VDDQ   | VSS    | DQS1_t_A | VSS    | VDDQ |
| VSS    | DQ13_A | DQS1_c_A | DQ10_A | VSS  |
| VDD2   | DQ12_A | VDDQ     | DQ11_A | VDD1 |
| VSS    | VDD1   | VSS      | ZQ2    | VSS  |
| VDD2   | CA2_A  | CA3_A    | CA4_A  | VDD2 |
| CK_t_A | CK_c_A | VSS      | CA5_A  | VSS  |
| CKE2_A | VSS    | VDD2     | VSS    | VDD2 |
|        |        |          |        |      |
|        |        |          |        |      |

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| CKE2_B         | VSS    | VDD2     | VSS     | VDD2 |
|----------------|--------|----------|---------|------|
| СК <u>_†</u> В | CK_c_B | VSS      | CA5_B   | VSS  |
| VDD2           | CA2_B  | CA3_B    | CA4_B   | VDD2 |
| VSS            | VDD1   | VSS      | RESET_n | VSS  |
| VDD2           | DQ12_B | VDDQ     | DQ11_B  | VDD1 |
| VSS            | DQ13_B | DQS1_c_B | DQ10_B  | VSS  |
| VDDQ           | VSS    | DQS1_t_B | VSS     | VDDQ |
| VSS            | DQ14_B | DMI1_B   | DQ9_B   | VSS  |
| VDDQ           | DQ15_B | VDDQ     | DQ8_B   | DNU  |
| VSS            | VDD2   | VSS      | DNU     | DNU  |

NOTE 1 0.8 mm pitch (X-axis), 0.65 mm pitch (Y-axis), 22 rows.

NOTE 2 Top View, A1 in top left corner.

NOTE 3 ODT(ca)\_[x] balls are wired to ODT(ca)\_[x] pads of Rank 0 DRAM die. ODT(ca)\_[x] pads for other ranks (if present) are disabled in the package. NOTE 4 ZQ2, CKE2\_A, CKE2\_B, CS2\_A, and CS2\_B balls are reserved for 3-rank package. For 1-rank and 2-rank package those balls are NC.

NOTE 5 Die pad VSS and VSSQ signals are combined to VSS package balls.

NOTE 6 Package requires dual channel die or functional equivalent of single channel die-stack.



#### NOTES FOR CMOS DEVICES

#### ① PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

#### **②** HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

#### **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.



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#### [Product usage]

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#### [Usage environment]

Usage in environments with special characteristics as listed below was not considered in the design.

Accordingly, our company assumes no responsibility for loss of a customer or a third party when used in environments with the special characteristics listed below.

#### Example:

- Usage in liquids, including water, oils, chemicals and organic solvents.
   Usage in exposure to direct sunlight or the outdoors, or in dusty places.
- 3) Usage involving exposure to significant amounts of corrosive gas, including sea air, CL2, H2S, NH3, SO2, and NOx.
  4) Usage in environments with static electricity, or strong electromagnetic waves or radiation.
- Usage in places where dew forms. 5)
- 6) Usage in environments with mechanical vibration, impact, or stress.
- 7) Usage near heating elements, igniters, or flammable items.

If you export the products or technology described in this document that are controlled by the Foreign Exchange and Foreign Trade Law of Taiwan, you must follow the necessary procedures in accordance with the relevant laws and regulations of Taiwan. Also, if you export products/technology controlled by U.S. export control regulations, or another country's export control laws or regulations, you must follow the necessary procedures in accordance with such laws or regulations.

If these products/technology are sold, leased, or transferred to a third party, or a third party is granted license to use these products, that third party must be made aware that they are responsible for compliance with the relevant laws and regulations.

